DRV8311 Three-Phase PWM Motor Driver

ADVANCE INFORMATION

1 Features

- Three-phase PWM motor driver
  - 3-Phase brushless DC motors
- 3-V to 20-V operating voltage
  - 24-V Absolute maximum voltage
- High output current capability
  - 5-A Peak current drive
- Low on-state resistance MOSFETs
  - 200-mΩ typ $R_{DS(ON)}$ (HS + LS) at T_A = 25°C
- Low power sleep mode
  - 1.5-µA at V_{VM} = 12-V, T_A = 25°C
- Multiple control interface options
  - 6x PWM control interface
  - 3x PWM control interface
  - PWM generation mode (SPI/tSPI) with optional calibration between MCU and DRV8311
- tSPI interface (DRV8311P)
  - PWM duty and frequency update over SPI
  - Control multiple DRV8311P devices using standard 4-wire SPI interface
- Supports up to 200-kHz PWM frequency
- Integrated current sensing
  - No external resistor required
  - Sense amplifier output, one per 1/2-H
- SPI and hardware device variants
  - 10-MHz SPI communication (SPI/tSPI)
- Supports 1.8-V, 3.3-V, and 5-V logic inputs
- Built-in 3.3-V ± 4.5%, 100-mA LDO regulator
- Integrated protection features
  - VM undervoltage lockout (UVLO)
  - Charge pump undervoltage (CPUV)
  - Overcurrent protection (OCP)
  - Thermal warning and shutdown (OTW/OTSD)
  - Fault condition indication pin (nFAULT)

2 Applications

- Brushless-DC (BLDC) Motor Modules
- Drones and Handheld Gimbal
- Coffee Machines
- Vacuum Robots
- Washer and Dryer Pumps
- Laptop, Desktop, and Server Fans

3 Description

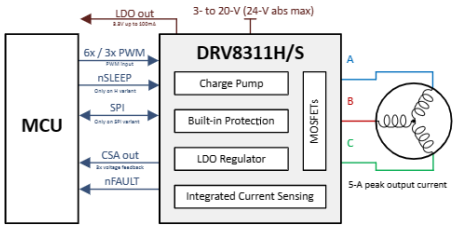
The DRV8311 provides three integrated MOSFET half-H-bridges for driving a three-phase brushless DC (BLDC) motor for 9-V, 12-V, or 18-V DC rails or 1S to 4S battery powered applications. The device integrates three current-sense amplifiers (CSA) with integrated current sense for sensing the three phase currents of BLDC motors to achieve optimum FOC and current-control system implementation.

The DRV8311P device provides capability to generate and configure PWM timers over Texas Instruments SPI (tSPI), and allows the control of multiple BLDC motors directly over the tSPI interface. This feature reduces the number of required I/O ports from the primary controller to control multiple motors.

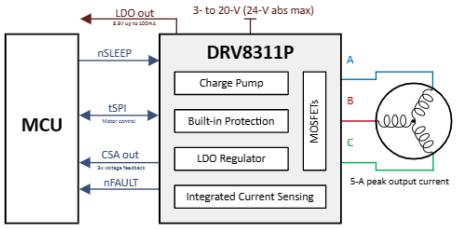
Device Information(1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)
DRV8311H	WQFN (24)	3.00 mm × 3.00 mm
DRV8311S(2)	WQFN (24)	3.00 mm × 3.00 mm
DRV8311P	WQFN (24)	3.00 mm × 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.
(2) Device available for preview only.



DRV8311H/S Simplified Schematic



DRV8311P Simplified Schematic

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4 Revision History

DATE	REVISION	NOTES
September 2021	*	Initial release.

5 Pin Configuration and Functions

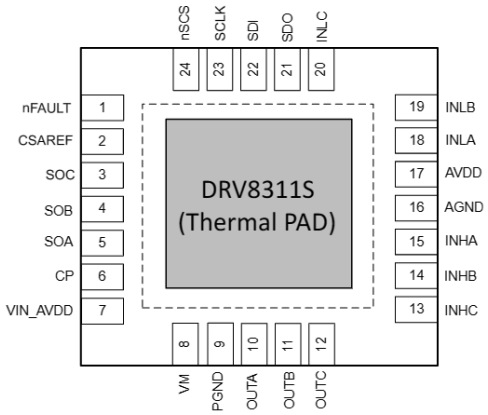

Figure 5-1. DRV8311S 24-Pin WQFN With Exposed Thermal Pad Top View

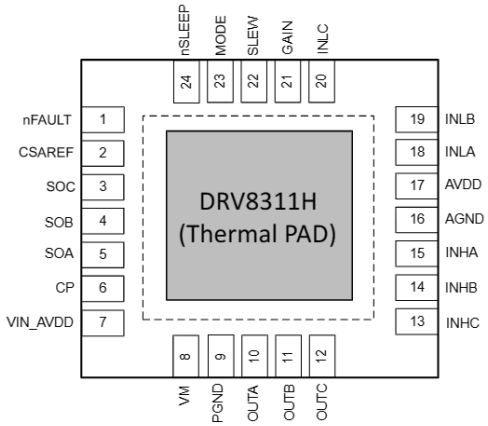

Figure 5-2. DRV8311H 24-Pin WQFN With Exposed Thermal Pad Top View

ADVANCE INFORMATION

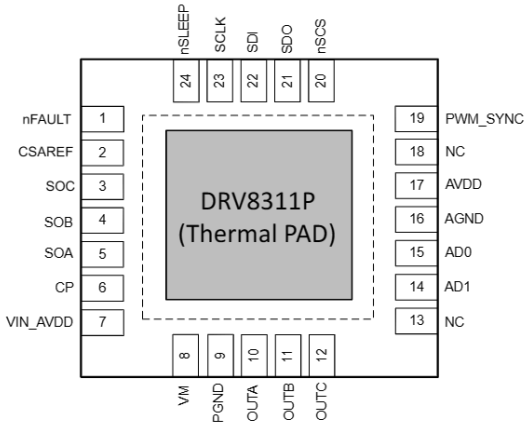

Figure 5-3. DRV8311P 24-Pin WQFN With Exposed Thermal Pad Top View

Table 5-1. Pin Functions

PIN	24-pin Package			TYPE(1)	DESCRIPTION
NAME	DRV8311H	DRV8311P	DRV8311S		
ADo	—	15	—	I	Only on tSPI device DRV8311P. Address selection for tSPI.
AD1	—	14	—	I	Only on tSPI device DRV8311P. Address selection for tSPI.
AGND	16	16	16	PWR	Device analog ground. Connect to system ground.
AVDD	17	17	17	PWR	3.3V regulator output. Connect a X5R or X7R, up to 4.7-µF, 6.3-V ceramic capacitor between the AVDD and AGND pins. This regulator can source up to 100 mA externally.
CP	6	6	6	PWR	Charge pump output. Connect a X5R or X7R, 0.1-µF, 16-V ceramic capacitor between the VCP and VM pins.
CSAREF	2	2	2	PWR	Current sense amplifier power supply input and reference. Connect a X5R or X7R, 0.1-µF, 6.3-V ceramic capacitor between the CSAREF and AGND pins.
GAIN	21	—	—	I	Only on Hardware devices (DRV8311H). Current sense amplifier gain setting. The pin is a 4 level input pin configured by an external resistor between GAIN and AVDD or GND.
INHA	15	—	15	I	High-side driver control input for OUTA. This pin controls the state of the high-side MOSFET in 6x/3x PWM Mode.
INHB	14	—	14	I	High-side driver control input for OUTB. This pin controls the state of the high-side MOSFET in 6x/3x PWM Mode.
INHC	13	—	13	I	High-side driver control input for OUTC. This pin controls the state of the high-side MOSFET in 6x/3x PWM Mode.
INLA	18	—	18	I	Low-side driver control input for OUTA. This pin controls the state of the low-side MOSFET in 6x PWM Mode.
INLB	19	—	19	I	Low-side driver control input for OUTB. This pin controls the state of the low-side MOSFET in 6x PWM Mode.
INLC	20	—	20	I	Low-side driver control input for OUTC. This pin controls the state of the low-side MOSFET in 6x PWM Mode.
MODE	23	—	—	I	Only on Hardware devices (DRV8311H). PWM mode setting. This pin is a 4 level input pin configured by an external resistor between MODE and AVDD or GND.
nFAULT	1	1	1	O	Fault indication pin. Pulled logic-low with fault condition; open-drain output requires an external pullup to AVDD.

Table 5-1. Pin Functions (continued)

PIN	24-pin Package			TYPE[1]	DESCRIPTION
NAME	DRV8311H	DRV8311P	DRV8311S		
nSCS	—	20	24	I	Only on SPI (DRV8311S) and tSPI (DRV8311P) devices. Serial chip select. A logic low on this pin enables serial interface communication (SPI devices).
nSLEEP	24	24	—	I	Only on DRV8311H and DRV8311P devices. When this pin is logic low the device goes to a low-power sleep mode. A 15 to 50-µs low pulse can be used to reset fault conditions without entering sleeep mode.
OUTA	10	10	10	O	Half bridge output A. Connect to motor winding.
OUTB	11	11	11	O	Half bridge output B. Connect to motor winding.
OUTC	12	12	12	O	Half bridge output C. Connect to motor winding.
PGND	9	9	9	PWR	Device power ground. Connect to system ground.
PWM_SYNC	—	18	—	I	Only on tSPI device DRV8311P. Connect to the MCU signal to synchronize the internally-generated PWM signals from DRV8311 to the MCU in PWM generation mode.
SCLK	—	23	23	I	Only on SPI (DRV8311S) and tSPI (DRV8311P) devices. Serial clock input. Serial data is shifted out on the rising edge and captured on the falling edge of SCLK (SPI devices).
SDI	—	22	22	I	Only on SPI (DRV8311S) and tSPI (DRV8311P) devices. Serial data input. Data is captured on the falling edge of the SCLK pin (SPI devices).
SDO	—	21	21	O	Only on SPI (DRV8311S) and tSPI (DRV8311P) devices. Serial data output. Data is shifted out on the rising edge of the SCLK pin.
SLEW	22	—	—	I	Only on DRV8311H device. Slew rate control setting. This pin is a 4 level input pin set by an external resistor between SLEW pin and AVDD or GND.
SOA	5	5	5	O	Current sense amplifier output for OUTA.
SOB	4	4	4	O	Current sense amplifier output for OUTB.
SOC	3	3	3	O	Current sense amplifier output for OUTC.
VM	8	8	8	PWR	Power supply for the motor. Connect to motor supply voltage. Connect a X5R or X7R, 0.1-uF VM-rated ceramic bypass capacitor as well as a >=10-uF, VM-rated bulk capacitor between VM and PGND. Additionally, connect a X5R or X7R, 0.1-uF, 16-V ceramic capacitor between the VM and CP pins.
VIN_AVDD	7	7	7	PWR	Supply input for AVDD. Bypass to AGND with a X5R or X7R, 0.1-uF, VIN_AVDD-rated ceramic capacitor as well as a >=10-uF, VIN_AVDD-rated rated bulk capacitor between VIN_AVDD and PGND.
Thermal pad				PWR	Must be connected to PGND.
NC	—	13,18	—	—	No connect. Leave the pin floating.

(1) I = input, O = output, PWR = power, NC = no connect

ADVANCE INFORMATION

6 Specifications

6.1 Absolute Maximum Ratings

over operating ambient temperature range (unless otherwise noted)(1)

	MIN	MAX	UNIT
Power supply pin voltage (VM)	–0.3	24	V
AVDD regulator input pin voltage (VIN_AVDD)	–0.3	24	V
Voltage difference between ground pins (PGND, AGND)	–0.3	0.3	V
Charge pump voltage (CP)	–0.3	V_M + 6	V
Analog regulator output pin voltage (AVDD)	–0.3	4	V
Logic pin input voltage (INHx, INLx, nSCS, nSLEEP, SCLK, SDI, ADx, GAIN, MODE, SLEW, PWM_SYNC)	–0.3	6	V
Logic pin output voltage (nFAULT, SDO)	–0.3	6	V
Open drain output current range (nFAULT)	0	5	mA
Current sense amplifier reference supply input (CSAREF)	–0.3	4	V
Current sense amplifier output (SOx)	–0.3	4	V
Peak Output Current (OUTA, OUTB, OUTC)		5	A
Output pin voltage (OUTA, OUTB, OUTC)	–1	V_M + 1(2)	V
Ambient temperature, T_A	–40	125	°C
Junction temperature, T_J	–40	150	°C
Storage tempertaure, T_{stg}	–65	150	°C

(1) *Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.*
(2) VM + 1 V or 24 V (whichever is smaller).

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001(1)	±1000	V
$V_{(ESD)}$	Electrostatic discharge	Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002(2)	±250	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
V_{VM}	Power supply voltage	V_{VM}	3	12	20	V
VIN_AVDD	AVDD regulator input pin voltage	V_{VIN_AVDD}	3	12	20	V
f_{PWM}	Output PWM frequency	OUTA, OUTB, OUTC			200	kHz
I_{OUT} (1)	Peak output current	OUTA, OUTB, OUTC			5	A
V_{IN}	Logic input voltage	INHx, INLx, nSCS, nSLEEP, SCLK, SDI, ADx, GAIN, MODE, SLEW, PWM_SYNC	-0.1		5.5	V
V_{OD}	Open drain pullup voltage	nFAULT	-0.1		5.5	V
I_{OD}	Open drain output sink current	nFAULT			5	mA
V_{CSAREF}	CSA refernce input Voltage	CSAREF	2		3.6	V
I_{CSAREF}	CSA refernce input Current	CSAREF		2.5	7.5	mA

over operating ambient temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
T_A	Operating ambient temperature		–40		125	°C
T_J	Operating Junction temperature		–40		150	°C

(1) Power dissipation and thermal limits must be observed

6.4 Thermal Information

THERMAL METRIC(1)		DRV8311 QFN (RRW) 24 Pins	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	42.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	37.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	15.7	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	0.5	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	15.6	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	4.8	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.5 Electrical Characteristics

at T_J = –40°C to +150°C, V_{VM} = 3 to 20 V (unless otherwise noted). Typical limits apply for T_A = 25°C, V_{VM} = 12 V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER SUPPLIES						
I_{VMQ}	VM sleep mode current	V_{VM} = 12 V, nSLEEP = 0, T_A = 25 °C		1.5	3	µA
		nSLEEP = 0, T_A = 125 °C			9	µA
I_{VMS}	VM standby mode current	V_{VM} = 12 V, nSLEEP = 1, INHx = INLx = 0, SPI = 'OFF', T_A = 25 °C		7	9	mA
		nSLEEP = 1, INHx = INLx = 0, SPI = 'OFF'		8	10	mA
I_{VM}	VM operating mode current	V_{VM} = 12 V, nSLEEP = 1, f_{PWM} = 25 kHz, T_A = 25 °C		10	12	mA
		V_{VM} = 12 V, nSLEEP = 1, f_{PWM} = 200 kHz, T_A = 25 °C		12	14	mA
		nSLEEP =1, f_{PWM} = 25 kHz		10	12	mA
		nSLEEP =1, f_{PWM} = 200 kHz		12	15	mA
V_{AVDD}	Analog regulator voltage	V_{VM} > 4V, V_{VIN_AVDD} > 4.5V, 0 mA ≤ I_{AVDD} ≤ 100 mA	3.15	3.3	3.45	V
V_{AVDD}		V_{VM} > 3.5V, 3.5V ≤V_{VIN_AVDD} ≤ 4.5V, 0 mA ≤ I_{AVDD} ≤ 35 mA	3	3.3	3.6	V
V_{AVDD}		2.5V ≤V_{VIN_AVDD} ≤ 3.5V, 0 mA ≤ I_{AVDD} ≤ 10 mA	2.2	VIN_AVDD -0.3	3.4	V
V_{AVDD}		V_{VM} < 4V, V_{VIN_AVDD} > 4.5V, 0 mA ≤ I_{AVDD} ≤ 40 mA	3	3.3	3.6	V
V_{AVDD}		V_{VM} < 3.5V, 3.5V ≤V_{VIN_AVDD} ≤ 4.5V, 0 mA ≤ I_{AVDD} ≤ 20 mA	3	3.3	3.6	V
I_{AVDD_LIM}	External analog regulator current limit		148	200	250	mA

ADVANCE INFORMATION

at T_J = –40°C to +150°C, V_{VM} = 3 to 20 V (unless otherwise noted). Typical limits apply for T_A = 25°C, V_{VM} = 12 V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{AVDD}	External analog regulator load	V_{VM} > 4V, V_{VIN_AVDD} > 4.5V			100	mA
		V_{VM} < 4V, V_{VIN_AVDD} > 4.5V			40	mA
		V_{VM} > 3.5V, 3.6V ≤V_{VIN_AVDD} ≤ 4.5V			35	mA
		V_{VM} < 3.5V, 3.6V ≤V_{VIN_AVDD} ≤ 4.5V			20	mA
		2.5V ≤V_{VIN_AVDD} ≤ 3.6V			10	mA
C_{AVDD}	Capacitance on AVDD pin	I_{AVDD} ≤ 25 mA;	0.7	1	7	µF
		I_{AVDD} ≥ 25 mA;	3.3	4.7	7	µF
R_{AVDD}	AVDD Output Voltage Regulation	V_{VIN_AVDD} > 4.5V; I_{AVDD} ≤ 20 mA;	-3		3	%
		V_{VIN_AVDD} > 4.5V; 20 mA ≤ I_{AVDD} ≤ 40 mA;	-2		2	%
		V_{VIN_AVDD} > 4.5V; I_{AVDD} ≥ 40 mA;	-3		3	%
V_{VCP}	Charge pump regulator voltage	VCP with respect to VM		5		V
t_{WAKE}	Wakeup time	V_{VM} > V_{UVLO}, nSLEEP = 1 to Output ready		1	3	ms
t_{WAKE_CSA}	Wakeup time for CSA	V_{CSAREF} > V_{CSAREF_UV} to SOx ready, when nSLEEP = 1		30		µs
t_{SLEEP}	Turn-off time	nSLEEP = 0 to driver tri-stated		100	200	µs
t_{RST}	Reset Pulse time	nSLEEP = 0 period to reset faults	15		50	µs
LOGIC-LEVEL INPUTS (INHx, INLx, nSLEEP, SCLK, SDI)						
V_{IL}	Input logic low voltage		0		0.6	V
V_{IH}	Input logic high voltage		1.5		5.5	V
V_{HYS}	Input logic hysteresis		200		500	mV
I_{IL}	Input logic low current	V_{PIN} (Pin Voltage) = 0 V	–1		1	µA
I_{IH}	Input logic high current	nSLEEP, V_{PIN} (Pin Voltage) = 5 V			30	µA
		Other pins, V_{PIN} (Pin Voltage) = 5 V			50	µA
R_{PD}	Input pulldown resistance	nSLEEP		230	300	kΩ
		Other pins		160	200	kΩ
C_{ID}	Input capacitance			30		pF
LOGIC-LEVEL INPUTS (nSCS)						
V_{IL}	Input logic low voltage		0		0.6	V
V_{IH}	Input logic high voltage		1.5		5.5	V
V_{HYS}	Input logic hysteresis		200		500	mV
I_{IL}	Input logic low current	V_{PIN} (Pin Voltage) = 0 V			90	µA
I_{IH}	Input logic high current	V_{PIN} (Pin Voltage) = 5 V			70	µA
R_{PU}	Input pullup resistance			48		kΩ
C_{ID}	Input capacitance			30		pF
FOUR-LEVEL INPUTS (GAIN, MODE, SLEW)						
V_{L1}	Input mode 1 voltage	Tied to AGND	0		0.2*AVDD	V
V_{L2}	Input mode 2 voltage	47 kΩ +/- 5% tied to GND	0.27*AVDD	0.5*AVDD	0.545*AVDD	V
V_{L3}	Input mode 3 voltage	Hi-Z	0.606*AVDD	0.757*AVDD	0.909*AVDD	V
V_{L4}	Input mode 4 voltage	Tied to AVDD	0.94*AVDD		AVDD	V
R_{PU}	Input pullup resistance	To AVDD		48		kΩ
R_{PD}	Input pulldown resistance	To AGND		160		kΩ
OPEN-DRAIN OUTPUTS (nFAULT)						

ADVANCE INFORMATION

at T_J = –40°C to +150°C, V_{VM} = 3 to 20 V (unless otherwise noted). Typical limits apply for T_A = 25°C, V_{VM} = 12 V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{OL}	Output logic low voltage	I_{OD} = -5 mA			0.4	V
I_{OH}	Output logic high current	V_{OD} = 5 V	–1		1	µA
C_{OD}	Output capacitance			30		pF
PUSH-PULL OUTPUTS (SDO)						
V_{OL}	Output logic low voltage	I_{OP} = -5 mA, 2.2V ≤ V_{AVDD} ≤ 3V	0		0.55	V
		I_{OP} = -5 mA, 3V ≤ V_{AVDD} ≤ 3.6V	0		0.5	V
V_{OH}	Output logic high voltage	I_{OP} = 5 mA, 2.2V ≤ V_{AVDD} ≤ 3V	V_{AVDD} - 0.86		3	V
		I_{OP} = 5 mA, 3V ≤ V_{AVDD} ≤ 3.6V	V_{AVDD} - 0.5		3.6	V
I_{OL}	Output logic low current	V_{OP} = 0 V	–1		1	µA
I_{OH}	Output logic high current	V_{OP} = 5 V	–1		1	µA
C_{OD}	Output capacitance			30		pF
DRIVER OUTPUTS						
$R_{DS(ON)}$	Total MOSFET on resistance (High-side + Low-side)	6V ≥ V_{VM} ≥ 3 V, I_{OUT} = 1 A, T_J = 25°C		300	350	mΩ
$R_{DS(ON)}$	Total MOSFET on resistance (High-side + Low-side)	6V ≥ V_{VM} ≥ 3 V, I_{OUT} = 1 A, T_J = 150°C		450	500	mΩ
$R_{DS(ON)}$	Total MOSFET on resistance (High-side + Low-side)	V_{VM} ≥ 6 V, I_{OUT} = 1 A, T_J = 25°C		200	250	mΩ
$R_{DS(ON)}$	Total MOSFET on resistance (High-side + Low-side)	V_{VM} ≥ 6 V, I_{OUT} = 1 A, T_J = 150°C		330	375	mΩ
SR	Phase pin slew rate switching low to high (Rising from 20 % to 80 % of VM)	V_{VM} = 12V; SLEW = 00b (SPI Variant) or SLEW pin tied to AGND (HW Variant)	20	35	55	V/us
SR		V_{VM} = 12V; SLEW = 01b (SPI Variant) or SLEW pin to 47 kΩ +/- 5% tied to AGND (HW Variant)	50	75	100	V/us
SR		V_{VM} = 12V; SLEW = 10b (SPI Variant) or SLEW pin to Hi-Z (HW Variant)	150	180	210	V/us
SR		V_{VM} = 12V; SLEW = 11b (SPI Variant) or SLEW pin tied to AVDD (HW Variant)	180	230	280	Vus
SR	Phase pin slew rate switching high to low (Falling from 80 % to 20 % of VM)	V_{VM} = 12V; SLEW = 00b (SPI Variant) or SLEW pin tied to AGND (HW Variant)	20	35	55	V/us
		V_{VM} = 12V; SLEW = 01b (SPI Variant) or SLEW pin to 47 kΩ +/- 5% tied to AGND (HW Variant)	50	75	100	V/us
		V_{VM} = 12V; SLEW = 10b (SPI Variant) or SLEW pin to Hi-Z (HW Variant)	150	180	210	V/us
		V_{VM} = 12V; SLEW = 11b (SPI Variant) or SLEW pin tied to AVDD (HW Variant)	180	230	280	V/us

ADVANCE INFORMATION

at T_J = –40°C to +150°C, V_{VM} = 3 to 20 V (unless otherwise noted). Typical limits apply for T_A = 25°C, V_{VM} = 12 V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{DEAD}	Output dead time (high to low / low to high)	V_{VM} = 12V, SLEW = 00b (SPI Variant) or SLEW pin tied to AGND (HW Variant), HS driver ON to LS driver OFF; DEADTIME = 000b; Handshake only		900	1200	ns
		V_{VM} = 12V, SLEW = 01b (SPI Variant) or SLEW pin to 47 kΩ +/- 5% tied to AGND (HW Variant), HS driver ON to LS driver OFF; DEADTIME = 000b; Handshake only		600	750	ns
		V_{VM} = 12V, SLEW = 10b (SPI Variant) or SLEW pin to Hi-Z (HW Variant), HS driver ON to LS driver OFF; DEADTIME = 000b; Handshake only		400	550	ns
		V_{VM} = 12V, SLEW = 11b (SPI Variant) or SLEW pin tied to AVDD (HW Variant), DEADTIME = 000b; Handshake only		350	540	ns
		V_{VM} = 12 V; HS driver ON to LS driver OFF; DEADTIME = 001b		200		ns
		V_{VM} = 12 V; HS driver ON to LS driver OFF; DEADTIME = 010b		400		ns
		V_{VM} = 12 V; HS driver ON to LS driver OFF; DEADTIME = 011b		600		ns
		V_{VM} = 12 V; HS driver ON to LS driver OFF; DEADTIME = 100b		800		ns
		V_{VM} = 12 V; HS driver ON to LS driver OFF; DEADTIME = 101b		1000		ns
		V_{VM} = 12 V; HS driver ON to LS driver OFF; DEADTIME = 110b		1200		ns
		V_{VM} = 12 V; HS driver ON to LS driver OFF; DEADTIME = 111b		1400		ns
t_{PD}	Propagation delay (high-side / low-side ON/OFF)	INHx = 1 to OUTx transisition, V_{VM} = 12V, SLEW = 00b (SPI Variant) or SLEW pin tied to AGND (HW Variant)		1000	1500	ns
		INHx = 1 to OUTx transisition, V_{VM} = 12V, SLEW = 01b (SPI Variant) or SLEW pin to 47 kΩ +/- 5% tied to AGND (HW Variant)		700	1000	ns
		INHx = 1 to OUTx transisition, V_{VM} = 12V, SLEW = 10b (SPI Variant) or SLEW pin to Hi-Z (HW Variant)		450	750	ns
		INHx = 1 to OUTx transisition, V_{VM} = 12V, SLEW = 11b (SPI Variant) or SLEW pin tied to AVDD (HW Variant)		400	650	ns
t_{MIN_PULSE}	Minimum output pulse width	SLEW = 11b	500			ns
CURRENT SENSE AMPLIFIER						
G_{CSA}	Current sense gain (SPI Device)	CSA_GAIN = 00 (SPI Variant) or GAIN pin tied to AGND (HW Variant)		0.25		V/A
		CSA_GAIN = 01 (SPI Variant) or GAIN pin to 47 kΩ +/- 5% tied to GND (HW Variant)		0.5		V/A
		CSA_GAIN = 10 (SPI Variant) or GAIN pin to Hi-Z (HW Variant)		1		V/A
		CSA_GAIN = 11 (SPI Variant) or GAIN pin tied to AVDD (HW Variant)		2		V/A

ADVANCE INFORMATION

at T_J = –40°C to +150°C, V_{VM} = 3 to 20 V (unless otherwise noted). Typical limits apply for T_A = 25°C, V_{VM} = 12 V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
G_{CSA_ERR}	Current sense gain error	T_J = 25°C, I_{PHASE} < 2.5 A	–3.		3	%
		T_J = 25°C, I_{PHASE} > 2.5 A	–8		8	%
		I_{PHASE} < 2.5 A	–4.5		4.5	%
		I_{PHASE} > 2.5 A	–10		10	%
I_{MATCH}	Current sense gain error matching between phases A, B and C	T_J = 25°C	–5.5		5.5	%
			–5		5	%
FS_{POS}	Full scale positive current measurement		5			A
FS_{NEG}	Full scale negative current measurement				–5	A
V_{LINEAR}	SOX output voltage linear range		0.25		V_{VREF} – 0.25	V
I_{OFFSET_RT}	Current sense offset low side current in (Room Temperature)	T_J = 25°C, Phase current = 0 A, G_{CSA} = 0.25 V/A	–50		50	mA
		T_J = 25°C, Phase current = 0 A, G_{CSA} = 0.5 V/A	–50		50	mA
		T_J = 25°C, Phase current = 0 A, G_{CSA} = 1 V/A	–50		50	mA
		T_J = 25°C, Phase current = 0 A, G_{CSA} = 2 V/A	–50		50	mA
I_{OFFSET}	Current sense offset referred to low side current in	Phase current = 0 A, G_{CSA} = 0.25 V/A	–50		50	mA
		Phase current = 0 A, G_{CSA} = 0.5 V/A	–50		50	mA
		Phase current = 0 A, G_{CSA} = 1 V/A	–50		50	mA
		Phase current = 0 A, G_{CSA} = 2 V/A	–50		50	mA
t_{SET}	Settling time to ±1%, 30 pF on SOx pin	Step on SOx = 1.2 V, G_{CSA} = 0.25 V/A			1	µs
		Step on SOx = 1.2 V, G_{CSA} = 0.5 V/A			1	µs
		Step on SOx = 1.2 V, G_{CSA} = 1 V/A			1	µs
		Step on SOx = 1.2 V, G_{CSA} = 2 V/A			1	µs
V_{DRIFT}	Drift offset	Phase current = 0 A	–80		80	µA/°C
I_{CSAREF}	CSAREF input current	VREF = 3.0 V		1.7	3	mA
PROTECTION CIRCUITS						
V_{UVLO}	Supply undervoltage lockout (UVLO)	VM rising	2.6	2.7	2.8	V
		VM falling	2.5	2.6	2.7	V
V_{UVLO_HYS}	Supply undervoltage lockout hysteresis	Rising to falling threshold	60	125	210	mV
t_{UVLO}	Supply undervoltage deglitch time			5		µs
$V_{VINAVDD\_UV}$	AVDD supply input undervoltage lockout (VINAVDD_UV)	VIN_AVDD rising	2.6	2.7	2.8	V
		VIN_AVDD falling	2.5	2.6	2.7	V
$V_{VINAVDD\_UV\_HYS}$	AVDD supply input undervoltage lockout hysteresis	Rising to falling threshold	100	125	150	mV
$t_{VINAVDD\_UV}$	AVDD supply input undervoltage deglitch time			5		µs
V_{CPUV}	Charge pump undervoltage lockout (voltage with respect to VM)	V_{CP} rising	2	2.3	2.5	V
		V_{CP} falling	2	2.2	2.4	V
V_{CPUV_HYS}	Charge pump undervoltage lockout hysteresis	Rising to falling threshold	65	100	125	mV
t_{CPUV}	Charge pump undervoltage lockout deglitch time			0.2		µs
V_{CSAREF_UV}	CSA reference undervoltage lockout	V_{CSAREF} rising	1.68	1.8	1.95	V
V_{CSAREF_UV}	CSA reference undervoltage lockout	V_{CSAREF} falling	1.6	1.7	1.85	V
$V_{CSAREF\_UV\_HYS}$	CSA reference undervoltage lockout hysteresis	Rising to falling threshold	80	90	100	mV

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at T_J = –40°C to +150°C, V_{VM} = 3 to 20 V (unless otherwise noted). Typical limits apply for T_A = 25°C, V_{VM} = 12 V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{AVDD_UV}	Analog regulator undervoltage lockout	V_{AVDD} rising	1.9	2	2.1	V
		V_{AVDD} falling	1.7	1.8	1.9	V
I_{OCP}	Overcurrent protection trip point	OCP_LVL = 0 (SPI Variant) or MODE pin tied to AGND or MODE pin to Hi-Z (HW Variant)	5.8	9	11.5	A
		OCP_LVL = 1 (SPI Variant) or MODE pin tied to AVDD or MODE pin 47 kΩ +/- 5% tied to AGND (HW Variant)	3.4	5	7.5	A
t_{BLANK}	Overcurrent protection blanking time (SPI Variant)	OCP_TBLANK = 00b		0.2		µs
		OCP_TBLANK = 01b		0.5		µs
		OCP_TBLANK = 10b		0.8		µs
		OCP_TBLANK = 10b		1		µs
t_{BLANK}	Overcurrent protection blanking time (HW Variant)			0.2		µs
t_{OCP}	Overcurrent protection deglitch time (SPI Variant)	OCP_DEG = 00b		0.2		µs
		OCP_DEG = 01b		0.5		µs
		OCP_DEG = 10b		0.8		µs
		OCP_DEG = 11b		1		µs
t_{OCP}	Overcurrent protection deglitch time (HW Variant)			1		µs
t_{RETRY}	Overcurrent protection retry time (SPI Variant)	FAST_RETRY = 00b		0.5		ms
		FAST_RETRY = 01b		1		ms
		FAST_RETRY = 10b		2		ms
		FAST_RETRY = 11b		5		ms
		SLOW_RETRY = 00b		500		ms
		SLOW_RETRY = 01b		1000		ms
		SLOW_RETRY = 10b		2000		ms
		SLOW_RETRY = 11b		5000		ms
t_{RETRY}	Overcurrent protection retry time (HW Variant)			5		ms
T_{OTW}	Thermal warning temperature	Die temperature (T_J) Rising	170		185	°C
T_{OTW_HYS}	Thermal warning hysteresis	Die temperature (T_J)		25		°C
T_{TSD}	Thermal shutdown temperature	Die temperature (T_J) Rising	180		200	°C
T_{TSD_HYS}	Thermal shutdown hysteresis	Die temperature (T_J)		25		°C
T_{TSD}	Thermal shutdown temperature (LDO)	Die temperature (T_J) Rising	180		200	°C
T_{TSD_HYS}	Thermal shutdown hysteresis (LDO)	Die temperature (T_J)		25		°C

6.6 SPI Timing Requirements

		MIN	NOM	MAX	UNIT
t_{READY}	SPI ready after power up			1	ms
t_{HI_nSCS}	nSCS minimum high time	300			ns
t_{SU_nSCS}	nSCS input setup time	25			ns
t_{HD_nSCS}	nSCS input hold time	25			ns
t_{SCLK}	SCLK minimum period	100			ns
t_{SCLKH}	SCLK minimum high time	50			ns
t_{SCLKL}	SCLK minimum low time	50			ns
t_{SU_SDI}	SDI input data setup time	25			ns

		MIN	NOM	MAX	UNIT
t_{HD_SDI}	SDI input data hold time	25			ns
t_{DLY_SDO}	SDO output data delay time			15	ns
t_{EN_SDO}	SDO enable delay time			50	ns
t_{DIS_SDO}	SDO disable delay time			50	ns

6.7 SPI Secondary Mode Timings

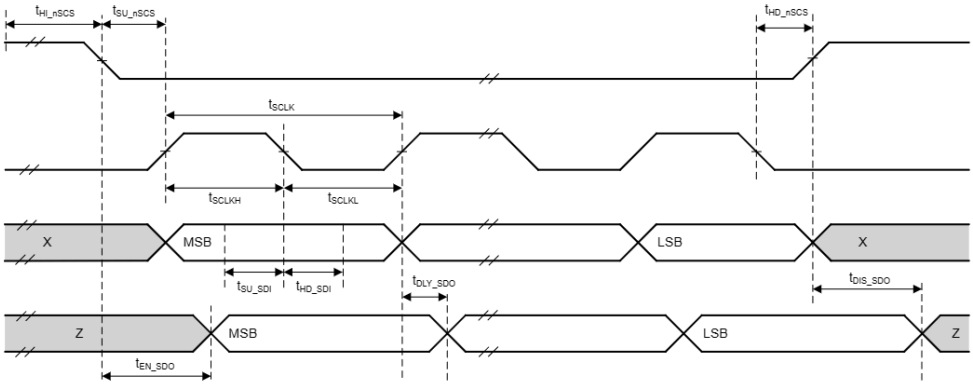

Figure 6-1. SPI Secondary Mode Timing Diagram

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7 Detailed Description

7.1 Overview

The DRV8311 is an integrated MOSFET driver for 3-phase motor-drive applications. The combined high-side and low-side FET's on-state resistance is 200-mΩ typical. The device reduces system component count, cost, and complexity by integrating three half-bridge MOSFETs, gate drivers, charge pump, current sense amplifier and linear regulator for an external load. For the DRV8311S, a standard serial peripheral interface (SPI) provides a simple method for configuring the various device settings and reading fault diagnostic information through an external controller. For the DRV8311H, a hardware interface (H/W) allows for configuring the most commonly used settings through fixed external resistors. For the DRV8311P, Texas Instruments SPI (tSPI) provides the ability to configure various device settings and adjust the PWM duty cycle and frequency to control multiple motors at a time.

The architecture uses an internal state machine to protect against short-circuit events, and protect against dV/dt parasitic turn on of the internal power MOSFETs.

The DRV8311 device integrates three bidirectional low side current-shunt amplifiers for monitoring the current through each of the half-bridges using a built-in current sense and no external current sense resistors are needed. The gain setting of the shunt amplifier can be adjusted through the SPI, tSPI or hardware interface.

In addition to the high level of device integration, the DRV8311 device provides a wide range of integrated protection features. These features include power supply undervoltage lockout (UVLO), charge pump undervoltage lockout (CPUV), overcurrent protection (OCP), AVDD undervoltage lockout (AVDD_UV) and overtemperature shutdown (OTW and OTSD). Fault events are indicated by the nFAULT pin with detailed information available in the registers on the SPI and tSPI device versions.

The DRV8311H, DRV8311P and DRV8311S devices are available in 0.4-mm pin pitch, WQFN surface-mount packages. The WQFN package size is 3.00 mm × 3.00 mm.

7.2 Functional Block Diagram

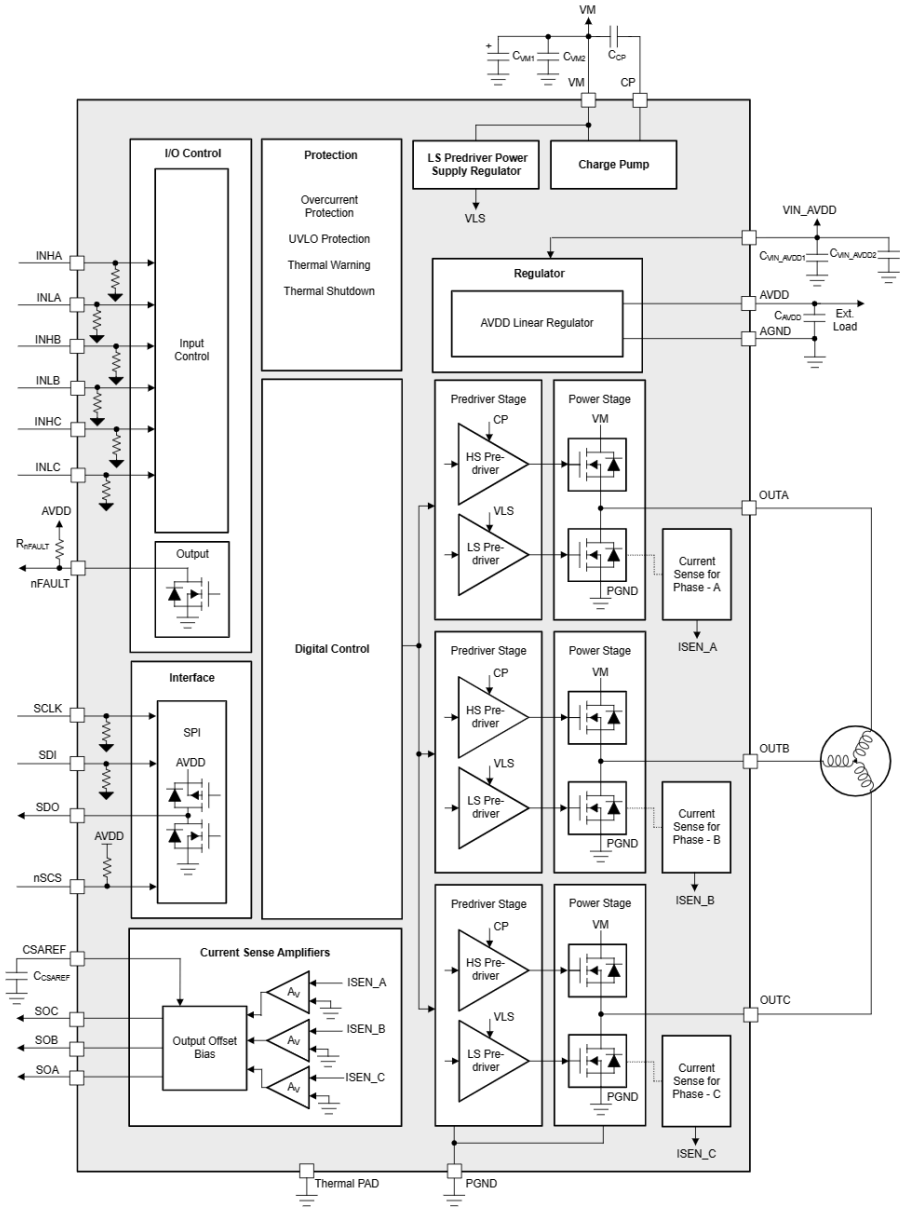

Figure 7-1. DRV8311S Block Diagram

ADVANCE INFORMATION

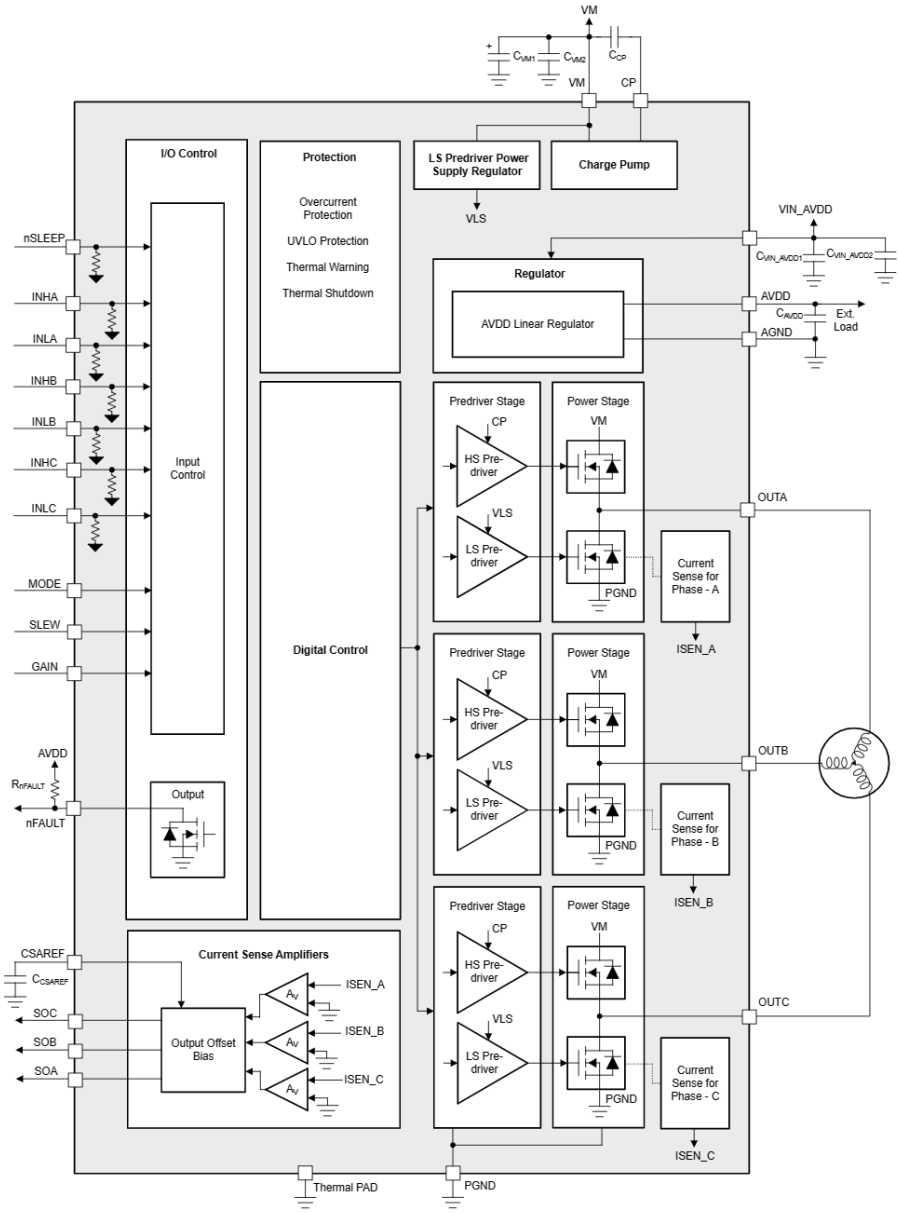

Figure 7-2. DRV8311H Block Diagram

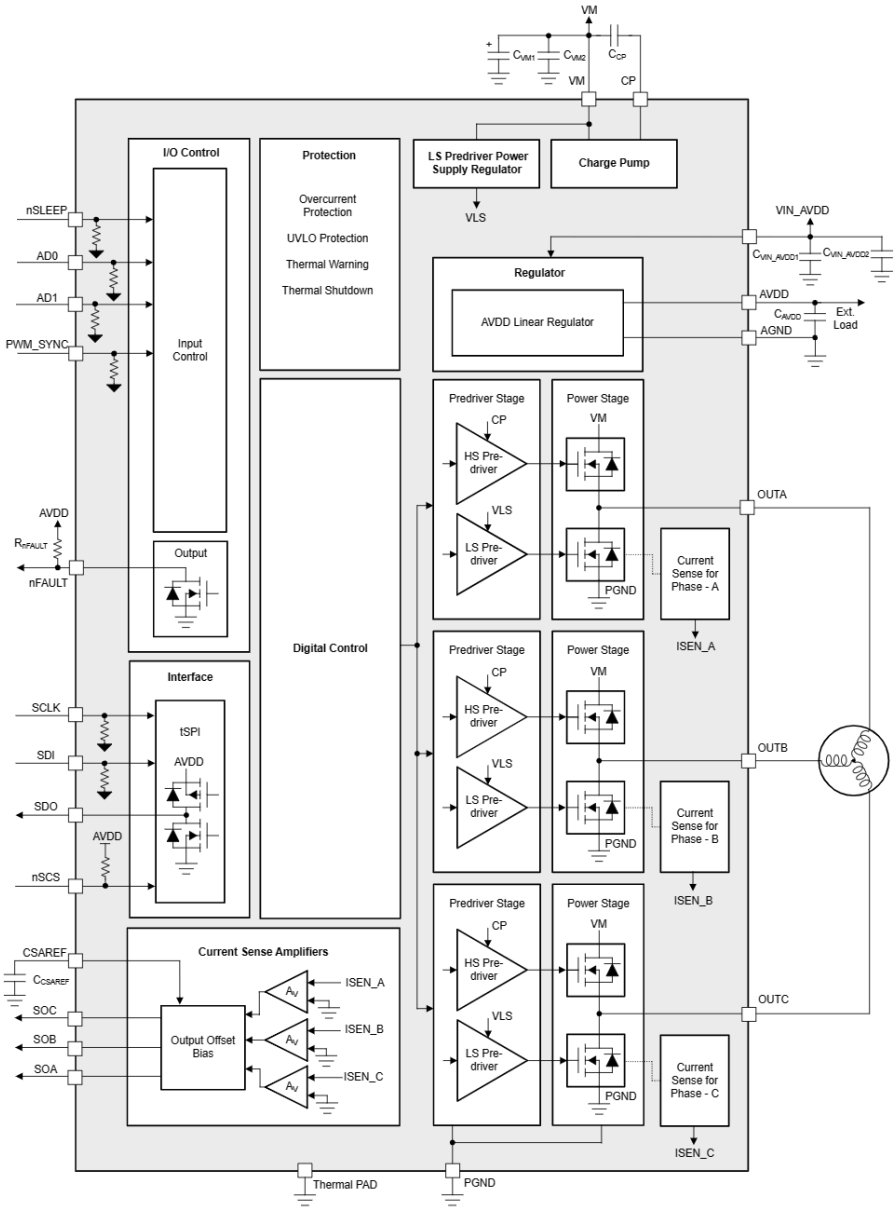

Figure 7-3. DRV8311P Block Diagram

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7.3 Feature Description

Table 7-1 lists the recommended values of the external components for the driver.

Table 7-1. DRV8311 External Components

COMPONENTS	PIN 1	PIN 2	RECOMMENDED
C_{VM1}	VM	PGND	X5R or X7R, 0.1-µF, VM-rated capacitor
C_{VM2}	VM	PGND	≥ 10-µF, VM-rated electrolytic capacitor
C_{VIN_AVDD1}	VIN_AVDD	AGND	X5R or X7R, 0.1-µF, VIN_AVDD-rated capacitor
C_{VIN_AVDD2}	VIN_AVDD	AGND	≥ 10-µF, VIN_AVDD-rated capacitor
C_{CP}	CP	VM	X5R or X7R, 16-V, 0.1-µF capacitor
C_{AVDD}	AVDD	AGND	X5R or X7R, 0.7 to 7-µF, 6.3-V capacitor
R_{nFAULT}	AVDD	nFAULT	5.1-kΩ, Pullup resistor
R_{SDO}	AVDD	SDO	5.1-kΩ, Pullup resistor (Optional)
R_{MODE}	MODE	AGND or AVDD	Section 7.3.3.2
R_{SLEW}	SLEW	AGND or AVDD	Section 7.3.3.2
R_{GAIN}	GAIN	AGND or AVDD	Section 7.3.3.2
C_{CSAREF}	CSAREF	AGND	X5R or X7R, 0.1-µF, CSAREF-rated capacitor

7.3.1 Output Stage

The DRV8311 device consists of integrated NMOS MOSFETs connected in a three-phase bridge configuration. A doubler charge pump provides the proper gate-bias voltage to the high-side NMOS MOSFETs across a wide operating voltage range in addition to providing 100% duty-cycle support. An internal linear regulator operating from the VM supply provides the gate-bias voltage (VLS) for the low-side MOSFETs.

7.3.2 Control Modes

The DRV8311 family of devices provides three different control modes to support various commutation and control methods. Table 7-2 shows the various modes of the DRV8311 device.

Table 7-2. PWM Control Modes

MODE Type	MODE Pin (DRV8311H)	MODE Bits (DRV8311S)	MODE Bits (DRV8311P)	MODE
Mode 1	Mode pin tied to AGND or Mode pin to 47 kΩ tied to AGND	PWM_MODE = 00b or PWM_MODE = 01b	NA	6x Mode
Mode 2	Mode pin Hi-Z or Mode pin tied to AVDD	PWM_MODE = 10b	NA	3x Mode
Mode 3	NA	PWM_MODE = 11b	PWM_MODE = 11b	PWM Generation Mode

Note

Texas Instruments do not recommend changing the MODE pin or MODE register during power up of the device (i.e. during tWAKE). The MODE setting on DRV8311H is latched at power up, so set nSLEEP = 0 before changing the MODE pin configuration on the DRV8311H. In DRV8311S, set all INHx and INLx pins to logic low before changing the MODE register.

7.3.2.1 6x PWM Mode (DRV8311S and DRV8311H variants only)

In 6x PWM mode, each half-bridge supports three output states: low, high, or high-impedance (Hi-Z). To configure DRV8311H in 6x PWM mode, connect the MODE pin to AGND or connect the MODE pin to 47 kΩ tied to AGND. To enable 6x PWM mode in DRV8311S configure the MODE bits with PWM_MODE = 00b or 01b. The corresponding INHx and INLx signals control the output state as listed in Table 7-3.

Table 7-3. 6x PWM Mode Truth Table

INLx	INHx	OUTx
0	0	Hi-Z
0	1	H
1	0	L
1	1	Hi-Z

Figure 7-4 shows the application diagram of DRV8311 configured in 6x PWM mode.

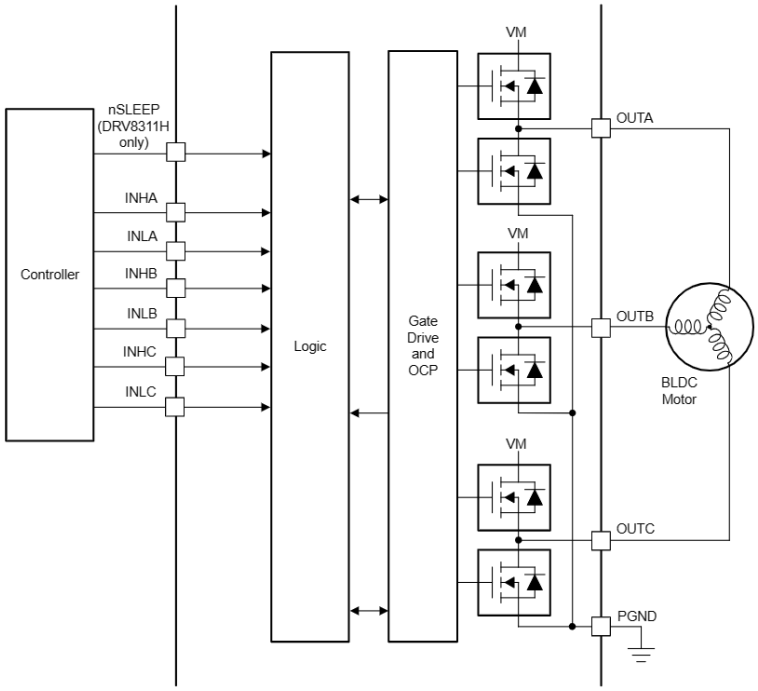

Figure 7-4. 6x PWM Mode

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7.3.2.2 3x PWM Mode (DRV8311S and DRV8311H variants only)

In 3x PWM mode, the INHx pin controls each half-bridge and supports two output states: low or high. To configure DRV8311H in 3x PWM mode, connect the MODE pin to AVDD or keep the MODE pin to Hi-Z. To enable 3x PWM mode in DRV8311S configure the MODE bits with PWM_MODE = 10b. The INLx pin is used to put the half bridge in the Hi-Z state. If the Hi-Z state is not required, tie all INLx pins to logic high (for example, by tying them to AVDD). The corresponding INHx and INLx signals control the output state as listed in Table 7-4.

Table 7-4. 3x PWM Mode Truth Table

INLx	INHx	OUTx
0	X	Hi-Z
1	0	L
1	1	H

Figure 7-5 shows the typical application diagram of the DRV8311 configured in 3x PWM mode.

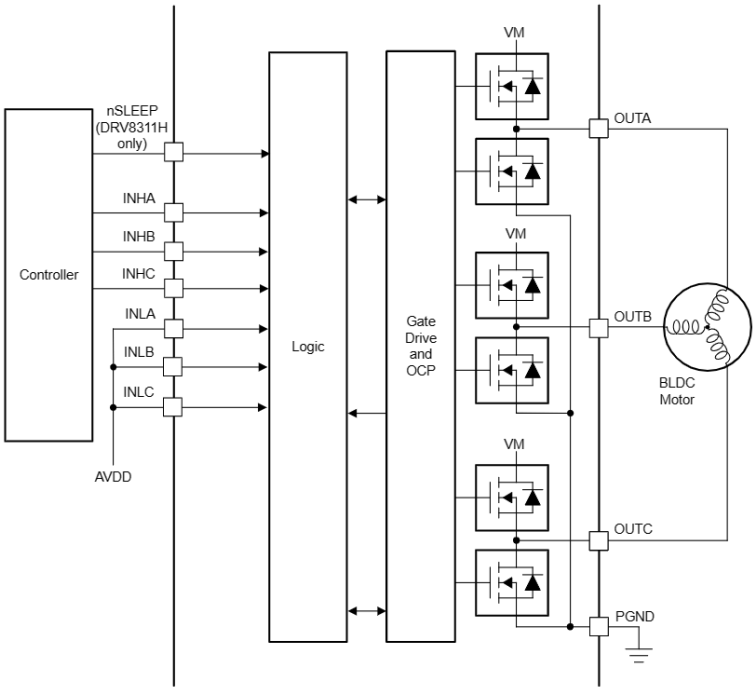

Figure 7-5. 3x PWM Mode

7.3.2.3 PWM Generation Mode (DRV8311S and DRV8311P Variants)

In PWM generation mode, the PWM signals are generated internally in the DRV8311 and can be controlled via a SPI (DRV8311S) or tSPI (DRV8311P) register read/write. This operation mode removes the need for controlling the motor through the INHx and INLx pins. The PWM period, frequency, and duty cycle for each phase can be configured over the serial interface. A PWM_SYNC pin functionality allows synchronization between the MCU and DRV8311. The PWM modes can be configured to enable or disable the high-side or low-side MOSFET PWM control for each phase in order to allow for continuous or discontinuous switching whenever required. When using the DRV8311S in PWM Generation mode, , connect the PWM_SYNC signal from MCU to the INLB pin of DRV8311S. The DRV8311S does not care about the state of all other INHx and INLx pins in this mode. Trapezoidal, sinusoidal, and FOC control are all possible using PWM generation mode.

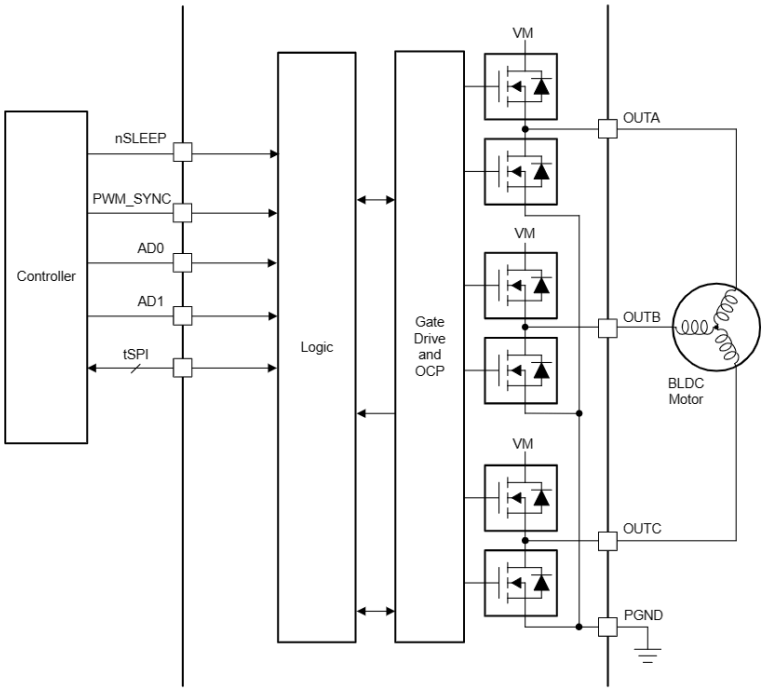

Figure 7-6. PWM Generation Mode - DRV8311P

ADVANCE INFORMATION

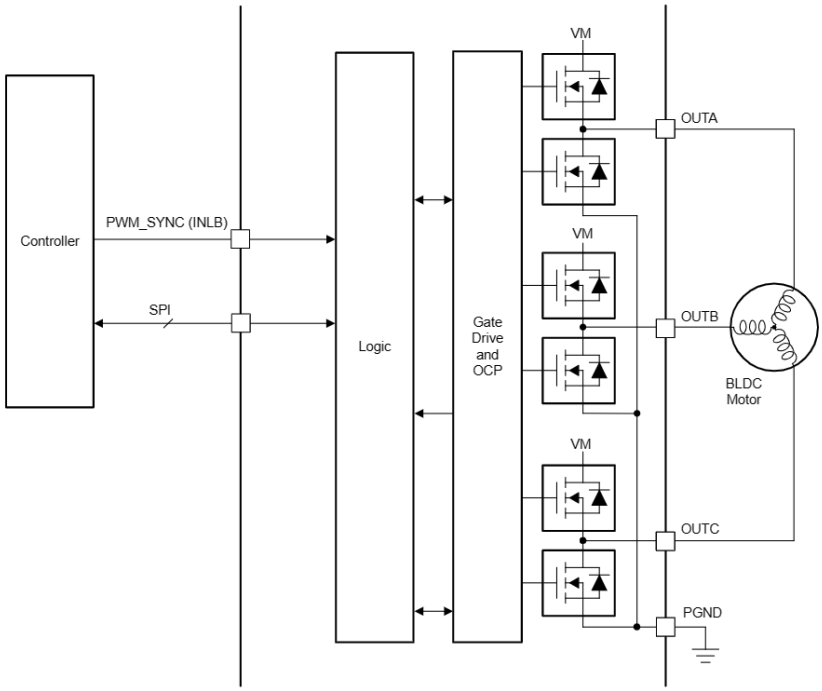

Figure 7-7. PWM Generation Mode - DRV8311S

PWM generation mode has three different options: up/down mode, up mode, and down mode. The PWM generation mode can be configured using PWMCNTR_MODE bits in the PWMG_CTRL register. The duty cycle defined by the PWM_DUTY_OUTx bits in the PWMG_A_DUTY register, of each phase is compared against the reference counter signal to generate the high side MOSFET PWM. The reference counter signal is generated internally based on the configuration of PWM_PRD_OUT bits (PWMG_PERIOD register) and PWMCNTR_MODE bits. If PWM_EN is high, the high side MOSFET PWM output is high when PWM_DUTY_OUTx is greater than the reference counter. For PWM_EN being low, the output is always held low. To achieve 100% duty cycle for the high side MOSFET [HS_ON for entire cycle], the PWM_DUTY_OUTx value must be higher than the PWM_PRD_OUT value.

In up/down mode [PWMCNTR_MODE = 0h], the reference counter waveform resembles a V shape, counting down from the PWM_PRD_OUT value when enabled and then counting up again once counter reaches zero. Configure the PWM_PRD_OUT bits to generate a PWM frequency (F_{PWM}) using the relation PWM_PRD_OUT = 0.5 x (F_{SYS} /F_{PWM}). F_{SYS} is the DRV8311P internal system clock frequency (approximately 20MHz).

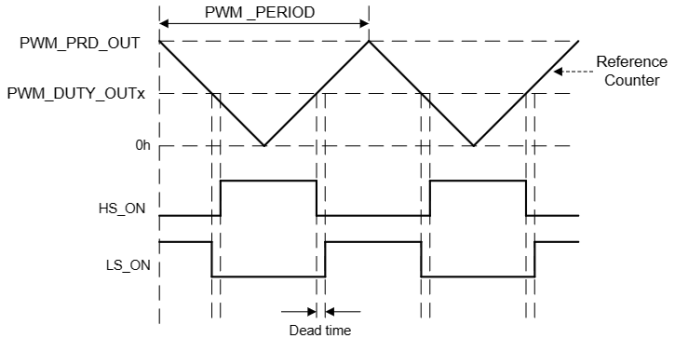

Figure 7-8. PWM Generation - Up/Down Mode

In up mode [PWMCNTR_MODE = 1h], the counter counts up from zero until it reaches the PWM_PRD_OUT value and then resets to zero. PWM_PRD_OUT = F_{SYS} /F_{PWM}

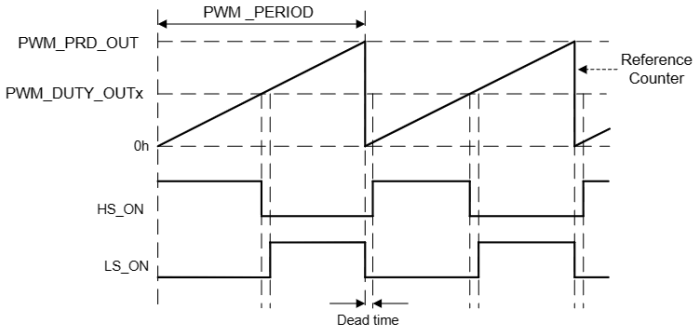

Figure 7-9. PWM Generation - Up Mode

In down mode [PWMCNTR_MODE = 2h], the counter counts down from the PWM_PRD_OUT value until it reaches zero and then resets to PWM_PRD_OUT value. PWM_PRD_OUT = F_{SYS} /F_{PWM}

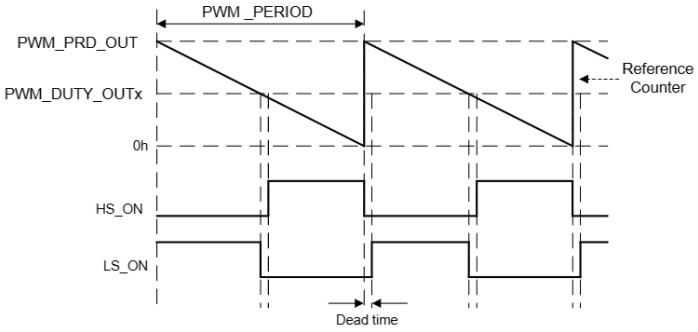

Figure 7-10. PWM Generation - Down Mode

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The dead time configured by the TDEAD_CTRL register is inserted between the LS_ON falling edge and the HS_ON rising edge as well as between HS_ON falling edge and LS_ON rising edge.

PWM Synchronization in PWM Generation Mode

When there is no dedicated INHx or INLx control signals, the external MCU can lose synchronization with PWM signal generated by the DRV8311. For synchronization, the external MCU sends one reference signal to the PWM_SYNC pin. PWM synchronization helps to generate the DRV8311 PWM output with the accuracy of the MCU clock and aligns PWM outputs with the MCU's ADC sampling the current sense outputs. The PWM_SYNC signal can also help to measure the DRV8311 internal oscillator frequency. DRV8311 also support auto-calibration of internal oscillator to calibrate the oscillator at 20MHz regardless of operating conditions. The DRV8311 allows five different methods of synchronizing between MCU and DRV8311 by configuring the PWM_OSC_SYNC bits of PWMG_CTRL register. The different synchronization methods are outlined below.

PWM_OSC_SYNC = 1h: The DRV8311 measures the PWM_SYNC signal period (PWM_SYNC_PRD) in counts of DRV8311 system clock F_{SYS} (approximately 20MHz). The MCU reads the register PWM_SYNC_PRD and can calibrate the PWM period. For example, assume that the MCU generate a 50% duty PWM_SYNC signal using an MCU timer with a period count of N and clock frequency F_{MCU}. The MCU read the PWM_SYNC_PERIOD register value say M, generated by DRV8311. The DRV8311 generates the PWM_SYNC_PERIOD using the DRV8311 system clock F_{SYS}(DRV). Now the MCU timer clock and the DRV8311 system clock are related by the equation F_{MCU} x M = F_{SYS}(DRV) x N.

The PWM_SYNC_PRD is 12bit and with DRV8311 internal system clock of approximately 20MHz, the minimum PWM_SYNC frequency that can be read without saturation is approximately 4.885 kHz (F_{SYS}/4095).

PWM_OSC_SYNC = 2h: The PWM_SYNC signal from the MCU is used to set the PWM period of DRV8311 and PWMG_PERIOD register setting is ignored. DRV8311 resets the PWM counter on rising edge of the PWM_SYNC.

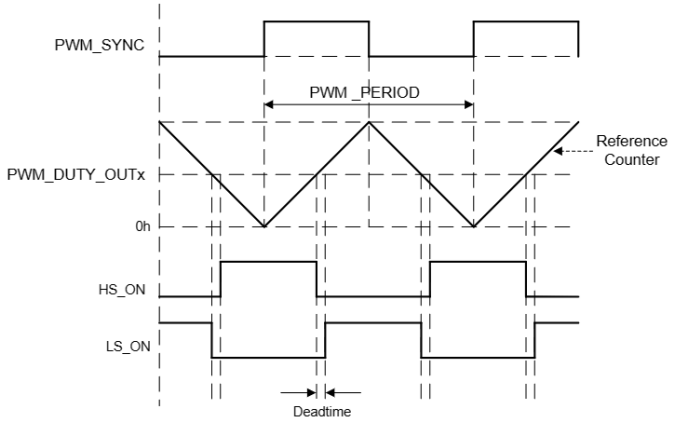

Figure 7-11. PWM Synchronization in Up/down Mode (PWM_OSC_SYNC = 2h)

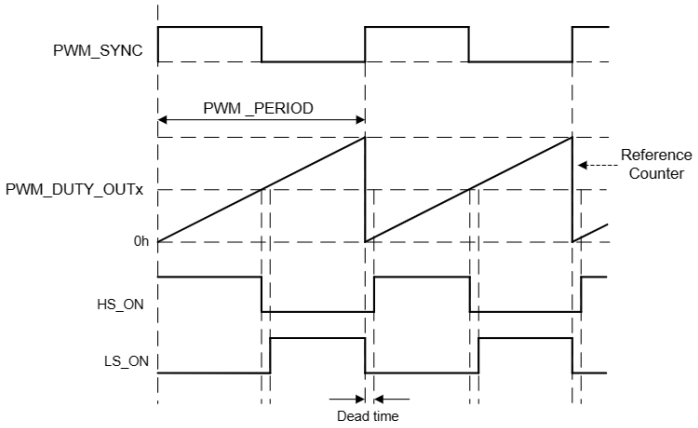

Figure 7-12. PWM Synchronization in Up Mode (PWM_OSC_SYNC = 2h)

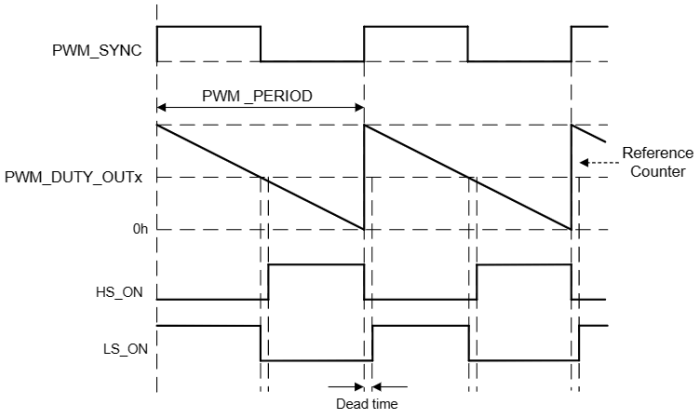

Figure 7-13. PWM Synchronization in Down Mode (PWM_OSC_SYNC = 2h)

PWM_OSC_SYNC = 5h: PWM_SYNC is used for oscillator synchronization (only 20 kHz frequency supported). For a PWM_SYNC signal of 20kHz, DRV8311 counts the number of internal system oscillator clock pulses between the rising edges of PWM_SYNC signal. For DRV8311 system clock at 20MHz, the number of clock pulses is expected to be 1000 in the ideal case. Deviation from this number implies an error in either the PWM frequency generated by DRV8311 or the PWM_SYNC frequency from the MCU. The PWM_SYNC frequency from MCU is assumed accurate and DRV8311 does oscillator calibration internally to calibrate the frequency at 20MHz and hence align PWM frequency generated with PWM_SYNC.

PWM_OSC_SYNC = 6h: PWM_SYNC is used for DRV8311 internal system oscillator calibration and setting PWM period (only 20 kHz frequency supported). The PWMG_PERIOD register setting is ignored. DRV8311 resets the PWM reference counter on rising edge of the PWM_SYNC.

PWM_OSC_SYNC = 7h: The SPI Clock pin SCLK is used for the DRV8311 internal system oscillator calibration to 20MHz. In this mode, the user has to configure the SPI clock frequency for synchronizing the oscillator (SPICLK_FREQ_SYNC) and the number of SPI clock cycles required for synchronizing the oscillator

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(SPISYNC_ACRCY) by configuring the PWMG_CTRL Register. The DRV8311 measures the total time for the entire SPI clock cycles (configured by SPISYNC_ACRCY) in counts of DRV8311 internal system clock F_{SYS} and calibrates the internal system clock to match the counts expected for 20MHz frequency. The DRV8311 system oscillator frequency accuracy after calibration compared to 20MHz depends on the configuration of SPISYNC_ACRCY.

7.3.3 Device Interface Modes

The DRV8311 family of devices supports three different interface modes (SPI, tSPI and hardware) to offer either increased simplicity (hardware interface) or greater flexibility and diagnostics (SPI interface). The SPI (DRV8311S) and hardware (DRV8311H) interface modes share the same four pins, allowing the different versions to be pin-to-pin compatible. Designers are encouraged to evaluate with the SPI interface version due to ease of changing settings, and may consider switching to the hardware interface with minimal modifications to the design.

7.3.3.1 Serial Peripheral Interface (SPI)

The SPI/tSPI devices support a serial communication bus that lets an external controller send and receive data with the DRV8311. This support allows the external controller to configure device settings and read detailed fault information. The interface is a four wire interface using the SCLK, SDI, SDO, and nSCS pins which are described as follows:

- The SCLK (serial clock) pin is an input that accepts a clock signal to determine when data is captured and propagated on the SDI and SDO pins.
- The SDI (serial data in) pin is the data input.
- The SDO (serial data out) pin is the data output.
- The nSCS (serial chip select) pin is the chip select input. A logic low signal on this pin enables SPI communication with the DRV8311.

For more information on the SPI, see *Section 7.5*.

7.3.3.2 Hardware Interface

Hardware interface devices omit the four SPI pins and in their place have nSLEEP pin and three resistor-configurable inputs which are GAIN, SLEW and MODE.

Common device settings can be adjusted on the hardware interface by tying the pin logic low, logic high, or pulling up or pulling down with a resistor. Fault conditions are reported on the nFAULT pin, but detailed diagnostic information is not available.

- The GAIN pin configures the gain of the current sense amplifier.
- The SLEW pin configures the slew rate of the output voltage to motor.
- The MODE pin configures the PWM control mode and OCP level.

For more information on the hardware interface, see *Section 7.3.9*.

Table 7-5. Hardware Pins Decode

Configuration	GAIN	SLEW	MODE
Pin tied to AGND	0.25 V/A	35 V/us	6x PWM Mode and 9A OCP Level
Pin to 47 kΩ tied to AGND	0.5 V/A	75 V/us	6x PWM Mode and 5A OCP Level
Pin to Hi-Z	1 V/A	180 V/us	3x PWM Mode and 9A OCP Level
Pin tied to AVDD	2 V/A	230 V/us	3x PWM Mode and 5A OCP Level

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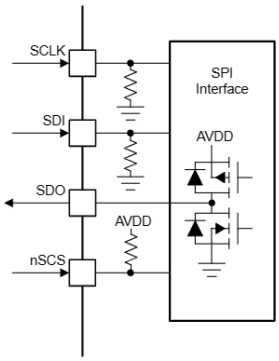

Figure 7-14. DRV8311 SPI Interface

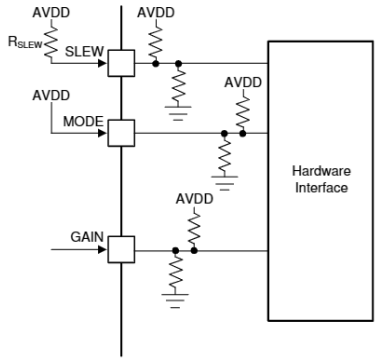

Figure 7-15. DRV8311 Hardware Interface

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7.3.4 AVDD Linear Voltage Regulator

A 3.3-V, 100mA linear regulator is integrated into the DRV8311 family of devices and is available to power external circuits. The AVDD regulator is used for powering up the internal digital functions of the DRV8311 and can also provide the supply voltage for a low-power MCU or other circuitry up to 100 mA. The output of the AVDD regulator should be bypassed near the AVDD and AGND pins with a X5R or X7R, up to 4.7-µF, 6.3-V ceramic capacitor routed directly back to the adjacent AGND ground pin.

The AVDD nominal, no-load output voltage is 3.3 V.

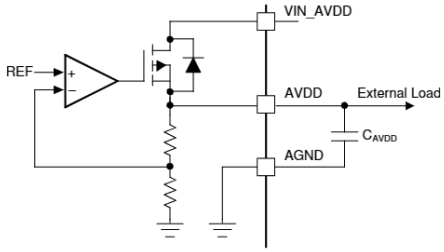

Figure 7-16. AVDD Linear Regulator Block Diagram

Use Equation 1 to calculate the power dissipated in the device by the AVDD linear regulator.

$$P = (V_{VIN\_AVDD} - V_{AVDD}) \times I_{AVDD} \quad (1)$$

The spply input voltage for AVDD regulator (VIN_AVDD) can be same as VM supply voltage, or lower or higher than VM supply voltage.

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7.3.5 Charge Pump

Because the output stages use N-channel FETs, the device requires a gate-drive voltage higher than the VM power supply to enhance the high-side FETs fully. The DRV8311 integrates a charge pump circuit that generates a voltage above the VM supply for this purpose.

The charge pump requires a single external capacitor for operation. See Table 7-1 for details on the capacitor value.

The charge pump shuts down when nSLEEP is low.

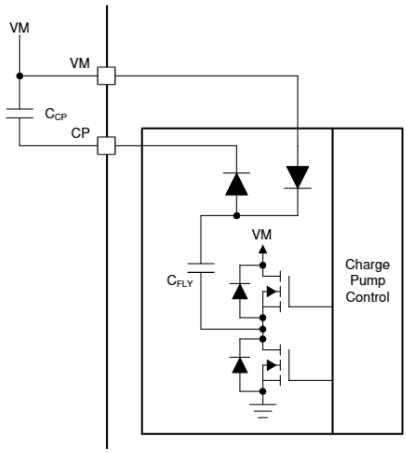

Figure 7-17. DRV8311 Charge Pump

7.3.6 Slew Rate Control

An adjustable gate-drive current control to the MOSFETs allows for easy slew rate control. The MOSFET VDS slew rates are a critical factor for optimizing radiated emissions, energy and duration of diode recovery spikes and switching voltage transients related to parasitics. These slew rates are predominantly determined by the rate of gate charge to internal MOSFETs as shown in Figure 7-18.

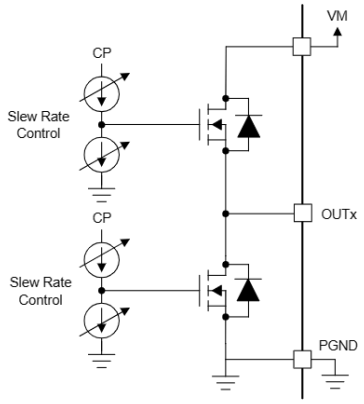

Figure 7-18. Slew Rate Circuit Implementation

The slew rate of each half-bridge can be adjusted by SLEW pin in hardware device variant or by using SLEW register settings in SPI device variant. Each half-bridge can be figured for a slew rate setting of 35-V/µs, 75-V/µs, 180-V/µs or 230-V/µs. The slew rate is calculated by the rise-time and fall-time of the voltage on OUTx pin as shown in Figure 7-19.

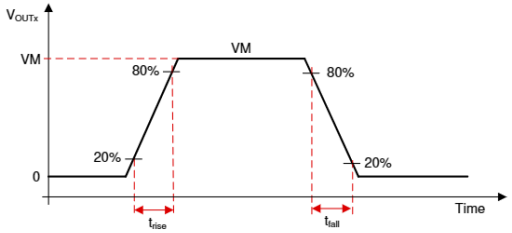

Figure 7-19. Slew Rate Timings

7.3.7 Cross Conduction (Dead Time)

The device is fully protected from cross conduction of MOSFETs. The high-side and low-side MOSFETs are operated to avoid any shoot through currents by inserting a dead time (t_{DEAD}). This is implemented by sensing the gate-source voltage (VGS) of the high-side and low-side MOSFETs and ensured that VGS of high-side MOSFET has reached below turn-off levels before switching on the low-side MOSFET of same half-bridge as shown in Figure 7-20 and Figure 7-21. The VGS of the high-side and low-side MOSFETs (VGS_HS and VGS_LS) shown in Figure 7-21 are DRV8311 internal signals.

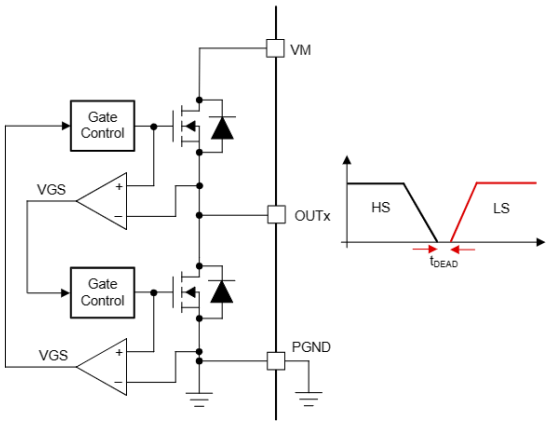

Figure 7-20. Cross Conduction Protection

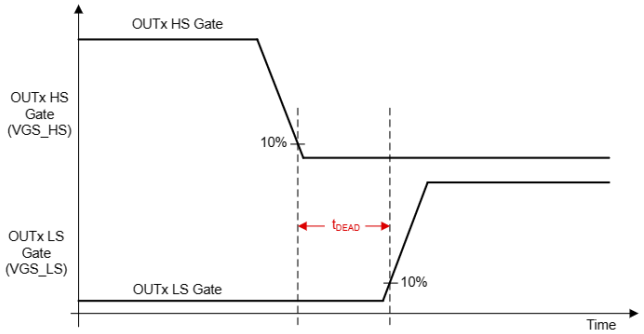

Figure 7-21. Dead Time

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7.3.8 Propagation Delay

The propagation delay time (t_{pd}) is measured as the time between an input logic edge to change in OUTx voltage. The propagation delay time includes the input deglitch delay, analog driver delay, and depends on the slew rate setting . The input deglitcher prevents high-frequency noise on the input pins from affecting the output state of the gate drivers. To support multiple control modes, a small digital delay is added as the input command propagates through the device.

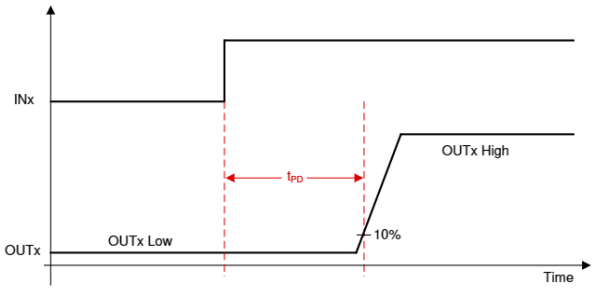

Figure 7-22. Propagation Delay

7.3.9 Pin Diagrams

This section presents the I/O structure of all digital input and output pins.

7.3.9.1 Logic Level Input Pin (Internal Pulldown)

Figure 7-23 shows the input structure for the logic levels pins INHx, INLx, nSLEEP,MODE, SCLK and SDI. The input can be driven with an external resistor to GND or an external logic voltage supply. It is recommended to pull these pins low in device sleep mode to reduce leakage current through the internal pull-down resistors.

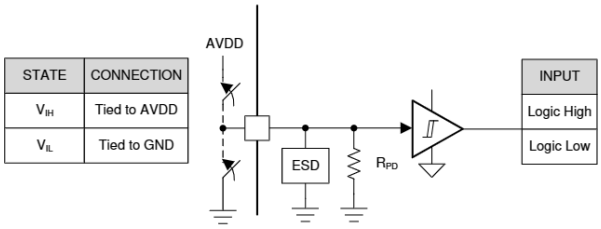

Figure 7-23. Logic-Level Input Pin Structure

7.3.9.2 Logic Level Input Pin (Internal Pullup)

Figure 7-24 shows the input structure for the logic level pin nSCS. The input can be driven with an external resistor to GND or an external logic voltage supply .

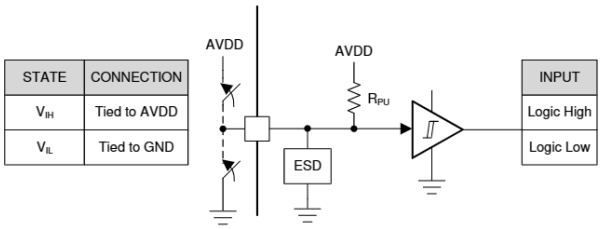

Figure 7-24. nSCS Input Pin Structure

7.3.9.3 Open Drain Pin

Figure 7-25 shows the structure of the open-drain output pin nFAULT. The open-drain output requires an external pullup resistor to a logic voltage supply to function properly.

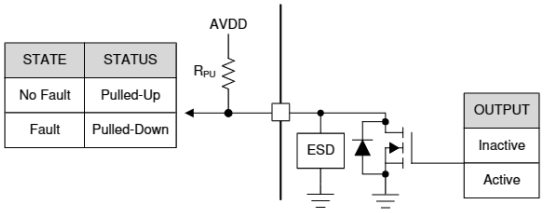

Figure 7-25. Open Drain Output Pin Structure

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7.3.9.4 Push Pull Pin

Figure 7-26 shows the structure of the push-pull pin SDO.

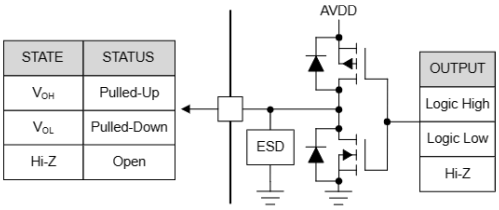

Figure 7-26. Push-Pull Output Pin Structure

7.3.9.5 Four Level Input Pin

Figure 7-27 shows the structure of the four level input pins GAIN and SLEW on hardware interface devices. The input can be set by tying the pin to AGND or AVDD, leaving the pin unconnected, or connecting an external resistor from the pin to ground.

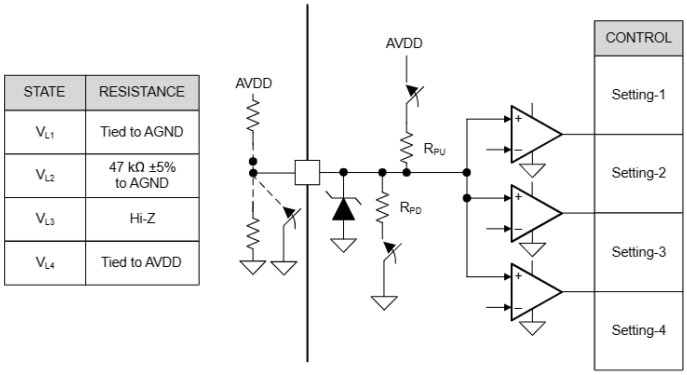

Figure 7-27. Four Level Input Pin Structure

7.3.10 Current Sense Amplifiers

The DRV8311 integrate three high-performance low-side current sense amplifiers for current measurements using built-in current sense. Low-side current measurements are commonly used to implement overcurrent protection, external torque control, or brushless DC commutation with the external controller. All three amplifiers can be used to sense the current in each of the half-bridge legs (low-side MOSFETs). The current sense amplifiers include features such as programmable gain and an external voltage reference (VREF) provided on the pin CSAREF.

7.3.10.1 Current Sense Amplifier Operation

The SOx pin on the DRV8311 outputs an analog voltage proportional to current flowing in the low side FETs (I_{OUTx}) multiplied by the gain setting (G_{CSA}). The gain setting is adjustable between four different levels which can be set by the GAIN pin (hardware device variant) or the CSA_GAIN bits (SPI or tSPI device variant).

Figure 7-28 shows the internal architecture of the current sense amplifiers. The current sense is implemented with a sense FET on each low-side FET of the DRV8311 device. This current information is converted in to a voltage, which generates the CSA output voltage on the SOx pin, based on the voltage on the CSAREF pin (VREF) and the gain setting. The CSA output voltage can be calculated using Equation 2

$$SOx = \frac{V_{REF}}{2} \pm \left(G_{CSA} \times I_{OUTx}\right) \quad (2)$$

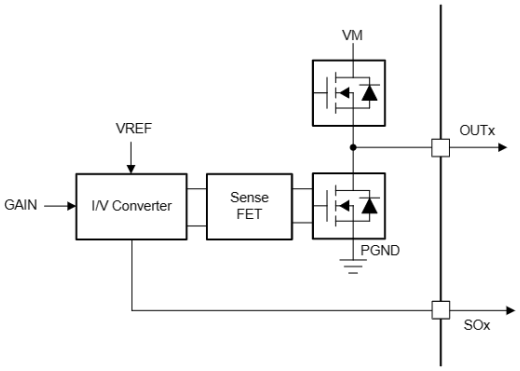

Figure 7-28. Integrated Current Sense Amplifier

Figure 7-29 and Figure 7-30 show the details of the amplifier operational range. In bi-directional operation, the amplifier output for 0-V input is set at VREF/2. Any change in the differential input results in a corresponding change in the output times the G_{CSA} factor. The amplifier has a defined linear region in which it can maintain operation.

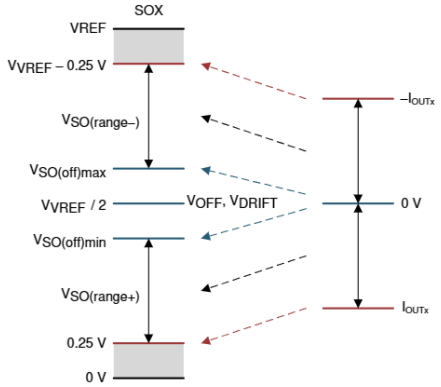

Figure 7-29. Bidirectional Current Sense Output

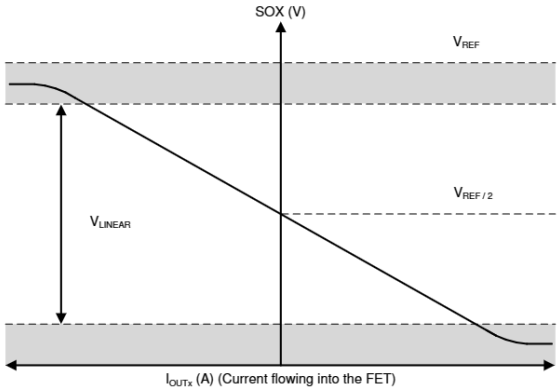

Figure 7-30. Bidirectional Current Sense Regions

Note

The current sense amplifers uses the externalvoltage reference (VREF) provided at the CSAREF pin.

7.3.10.2 Current Sense Amplifier Offset Correction

CSA output has an offset induced due to ground differences between the sense FET and output FET. When running trapezoidal control or another single-shunt based control (sensored sine, for example) this CSA offset has no impact to operation. When running sensorless sinusoidal or FOC control where two or three current sense are required, some current distortion and noise may occur unless the user implements the corrective action below.

Corrective Action: Implement the below equations in firmware to correct for any current induced offset:

1. When all three current sense amplifiers are used:

$$i_a = 1.001152 * i_{a\_sensed} - 0.003375 * i_{b\_sensed} - 0.003103 * i_{c\_sensed} \quad (3)$$

$$i_b = 0.002369 * i_{a_{sensed}} + 1.000665 * i_{b\_sensed} - 0.019126 * i_{c\_sensed} \quad (4)$$

$$i_c = 0.001234 * i_{a_{sensed}} + 0.001595 * i_{b_{sensed}} + 0.998166 * i_{c\_sensed} \quad (5)$$

2. When only two of the three current sense amplifiers are used:
   a. Current sensed in phases A & B:

$$i_a = 1.004346 * i_{a\_sensed} - 0.000199 * i_{b\_sensed} \quad (6)$$

$$i_b = 0.022060 * i_{a_{sensed}} + 1.020405 * i_{b\_sensed} \quad (7)$$

$$i_c = -(i_a + i_b) \quad (8)$$

   b. Current sensed in phases B & C:

$$i_b = 0.998309 * i_{b\_sensed} - 0.021427 * i_{c\_sensed} \quad (9)$$

$$i_c = 0.000368 * i_{b_{sensed}} + 0.996967 * i_{c\_sensed} \quad (10)$$

$$i_a = -(i_b + i_c) \quad (11)$$

   c. Current sensed in phases C & A

$$i_a = 1.004547 * i_{a_{sensed}} + 0.000195 * i_{c\_sensed} \quad (12)$$

$$i_c = 0.000371 * i_{a_{sensed}} + 0.996975 * i_{c\_sensed} \quad (13)$$

$$i_b = -(i_a + i_c) \quad (14)$$

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7.3.11 Protections

The DRV8311 family of devices is protected against VM, VIN_AVDD, AVDD and CP undervoltage, overcurrent and thermal events. Table 7-6 summarizes various faults details.

Table 7-6. Fault Action and Response

FAULT	CONDITION	CONFIGURATION	REPORT	H-BRIDGE	LOGIC	RECOVERY
VM undervoltage (NPOR)	$V_{VM} < V_{UVLO}$	—	—	Hi-Z	Disabled	Automatic: $V_{VM} > V_{UVLO\_R}$ CLR_FLT, nSLEEP Reset Pulse (NPOR bit)
VINAVDD undervoltage (VINAVDD_UV)	$V_{VINAVDD} < V_{VINAVDD\_UV}$	—	nFAULT	Hi-Z	Active (SPI disabled)	Configured using UVP_MODE
AVDD undervoltage (AVDD_UV)	$V_{AVDD} < V_{AVDD\_UV}$	—	nFAULT	Hi-Z	Active (SPI disabled)	Configured using UVP_MODE
Charge pump undervoltage (CP_UV)	$V_{CP} < V_{CPUV}$	—	nFAULT	Hi-Z	Active	Configured using UVP_MODE
CSAREF undervoltage (CSAREF_UV)	$V_{CSAREF} < V_{CSAREF\_UV}$	CSAREFUV_EN= 1b	nFAULT	Active (CSA disabled)	Active	Configured using UVP_MODE
		CSAREFUV_EN= 0b	None	Active	Active	No Action
Overcurrent Protection (OCP)	$I_{PHASE} > I_{OCP}$	OCP_MODE = 000b	nFAULT	Hi-Z	Active	Automatic Retry: SLOW_TRETRY
		OCP_MODE = 001b	nFAULT	Hi-Z	Active	Automatic Retry: FAST_TRETRY
		OCP_MODE = 010b	nFAULT	Hi-Z	Active	Latched: CLR_FLT, nSLEEP Reset Pulse
		OCP_MODE = 011b	nFAULT	Active	Active	No action
		OCP_MODE = 111b	None	Active	Active	No action
SPI error (SPI_FLT)	SCLK fault and ADDR fault	SPIFLT_MODE = 0b	nFAULT	Active	Active	Automatic
		SPIFLT_MODE = 1b	None	Active	Active	No action
Thermal warning (OTW)	$T_J > T_{OTW}$	OTW_EN = 0b	None	Active	Active	No action
		OTW_EN = 1b	nFAULT	Active	Active	Automatic: $T_J < T_{OTW} - T_{HYS}$
Thermal shutdown (OTSD)	$T_J > T_{OTSD}$	OTSD_MODE = 00b	nFAULT	Hi-Z	Active	Automatic SLOW_TRETRY after $T_J < T_{OTSD} - T_{HYS}$
		OTSD_MODE = 01b	nFAULT	Hi-Z	Active	Automatic FAST_TRETRY after $T_J < T_{OTSD} - T_{HYS}$

7.3.11.1 VM Supply Undervoltage Lockout (NPOR)

If at any time the input supply voltage on the VM pin falls lower than the V_{UVLO} threshold (VM UVLO falling threshold), all of the integrated FETs, driver charge-pump and digital logic controller are disabled as shown in Figure 7-31. Normal operation resumes (driver operation) when the VM undervoltage condition is removed. The NPOR bit is reset and latched low in the device status (DEV_STS1) register once the device presumes VM. The NPOR bit remains in reset condition until cleared through the CLR_FLT bit or an nSLEEP pin reset pulse (t_{RST}).

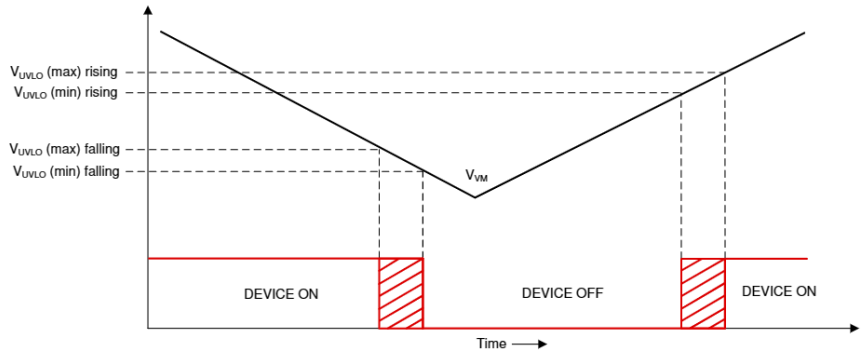

Figure 7-31. VM Supply Undervoltage Lockout

7.3.11.2 Under Voltage Protections (UVP)

Other than VM ULVO, DRV8311 family of devices has undervoltage protections for VIN_AVDD, CSAREF, AVDD and CP pins. VINAVDD_UV, CSAREF_UV and AVDD_UV undervoltage protections are enabled and cannot be disabled, while CSAREF_UV is disabled by default and can be enabled in SPI variant by configuring CSAREFUV_EN in SYSF_CTRL register.

In hardware device variants, AVDD_UV, VINAVDD_UV, CP_UV protections are enabled, while CSAREF_UV is disabled and the t_{RETRY} is configured for fast automatic rety time to 5 ms.

t_{RETRY} configuration for SPI device variant for all UV protections

- Slow retry time SLOW_TRETRY can be used for t_{RETRY} period by configuring UVP_MODE to 000b
- Fast retry time FAST_TRETRY can be used for t_{RETRY} period by configuring UVP_MODE to 001b

VIN AVDD Undervoltage Protections (VINAVDD_UV)

If at any time the voltage on VIN_AVDD pin falls lower than the $V_{VINAVDD\_UV}$ threshold, all of the integrated FETs, SPI communication is disabled, nFAULT pin is driven low, FAULT and UVP in DEV_STS1 and VINAVDD_UV in SUP_STS1 are set high. Normal operation starts again automatically (driver operation, the nFAULT pin is released and VINAVDD_UV bit is cleared) after VIN_AVDD pin rises above the $V_{VINAVDD\_UV}$ threshold and the t_{RETRY} time elapses. The FAULT and UVP bits stays latched high until a clear fault command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}).

AVDD Undervoltage Protections (AVDD_UV)

If at any time the voltage on AVDD pin falls lower than the V_{AVDD_UV} threshold, all of the integrated FETs, SPI communication is disabled, nFAULT pin is driven low, FAULT and UVP in DEV_STS1 and AVDD_UV in SUP_STS1 are set high. Normal operation starts again automatically (driver operation, the nFAULT pin is released and AVDD_UV bit is cleared) after AVDD pin rises above the V_{AVDD_UV} threshold and the t_{RETRY} time elapses. The FAULT and UVP bits stays latched high until a clear fault command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}).

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CSAREF Undervoltage Protections (CSAREF_UV)

If at any time the voltage on CSAREF pin falls lower than the V_{CSAREF_UV} threshold, CSAREF_UV is recognized. CSA_UV can be enabled or disabled by configuring CSAREFUV_EN. When enabled, after CSAREF_UV event,CSA are disabled, nFAULT pin is driven low, FAULT and UVP in DEV_STS1 and CSAREF_UV in SUP_STS1 are set high. Normal operation starts again automatically (CSA operation, the nFAULT pin is released and CSAREF_UV bit is cleared) after CSAREF_UV condition is cleared and the t_{RETRY} time elapses. The FAULT and UVP bits stays latched high until a clear fault command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}).

Note

CSAREF_UV is disabled in hardware variant and by default in SPI variants

CP Undervoltage Protections (CP_UV)

If at any time the voltage on CP pin falls lower than the V_{CP_UV} threshold, all of the integrated FETs and charge pump operation is disabled, nFAULT pin is driven low, FAULT and UVP in DEV_STS1 and CP_UV in SUP_STS1 are set high. Normal operation starts again automatically (driver and charge pump operation, the nFAULT pin is released and CP_UV bit is cleared) after CP pin rises above the the V_{CP_UV} threshold and the t_{RETRY} time elapses. The FAULT and UVP bits stays latched high until a clear fault command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}).

7.3.11.3 Overcurrent Protection (OCP)

A MOSFET overcurrent event is sensed by monitoring the current flowing through FETs. If the current across a FET exceeds the I_{OCP} threshold for longer than the t_{OCP} deglitch time, a OCP event is recognized and action is done according to the OCP_MODE bit. In order to avoid false triger of OCP during PWM trasnition due to ringing in phase voltage, there is t_{BLANK} blanking time applied at each edge of PWM signals in digital. During blanking time, OCP events are ignored.

On hardware device varaints, the I_{OCP} threshold is fixed to 9A (typ), the t_{OCP_DEG} is fixed at 1-µs, t_{BLANK} is fixed at 0.2-µs and the OCP_MODE bit is configured with fast retry with 5-ms automatic retry. On SPI devices, the I_{OCP} threshold is set through the OCP_LVL, the t_{OCP_DEG} is set through the OCP_DEG, the t_{BLANK} is set through the OCP_TBLANK and the OCP_MODE bit can operate in four different modes: OCP latched shutdown, OCP automatic retry with fast and slow retry times, OCP report only, and OCP disabled.

7.3.11.3.1 OCP Latched Shutdown (OCP_MODE = 010b)

After a OCP event in this mode, all MOSFETs are disabled and the nFAULT pin is driven low. The FAULT, OCP, and corresponding FET's OCP bits are latched high in the SPI registers. Normal operation starts again (driver operation, FAULT, OCP, and corresponding FET's OCP bits are cleared and the nFAULT pin is released) when the OCP condition clears and a clear faults command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}).

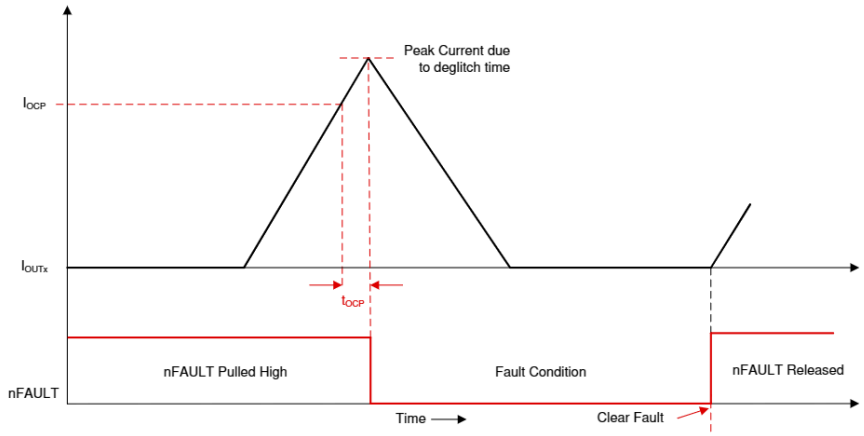

Figure 7-32. Overcurrent Protection - Latched Shutdown Mode

7.3.11.3.2 OCP Automatic Retry (OCP_MODE = 000b or 001b)

After a OCP event in this mode, all the FETs are disabled and the nFAULT pin is driven low. The FAULT, OCP, and corresponding FET's OCP bits are set high in the SPI registers. Normal operation starts again automatically (driver operation, the nFAULT pin is released and corresponding FET's OCP bits are cleared) after the t_{RETRY} time elapses. The FAULT and OCP stays latched high until clear faults command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}).

t_{RETRY} configuration

- Slow retry time SLOW_TRETRY can be used for t_{RETRY} period by configuring OCP_MODE to 000b
- Fast retry time FAST_TRETRY can be used for t_{RETRY} period by configuring OCP_MODE to 001b

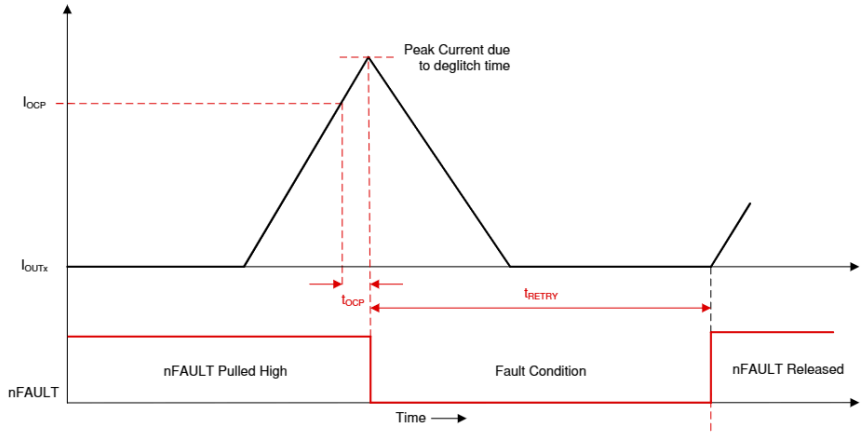

Figure 7-33. Overcurrent Protection - Automatic Retry Mode

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7.3.11.3.3 OCP Report Only (OCP_MODE = 011b)

No protective action occurs after a OCP event in this mode. The overcurrent event is reported by driving the nFAULT pin low and setting the FAULT, OCP, and corresponding FET's OCP bits high in the SPI registers. DRV8311 continue to operate as usual. The external controller manages the overcurrent condition by acting appropriately. The reporting clears (nFAULT pin is released, FAULT, OCP, and corresponding FET's OCP bits are cleared) when the OCP condition clears and a clear faults command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}).

7.3.11.3.4 OCP Disabled (OCP_MODE = 111b)

No action occurs after a OCP event in this mode.

7.3.11.4 Thermal Protections

DRV8311 family of devices has over temperature warning (OTW) and over temperature shutdown (OTSD) for over temperature events.

7.3.11.4.1 Thermal Warning (OTW)

If the die temperature exceeds the trip point of the thermal warning (T_{OTW}), the OT bit in the device status (DEV_STS1) register and OTW bit in the OT_STS status register is set. The reporting of OTW on the nFAULT pin can be enabled by setting the over-temperature warning reporting (OTW_EN) bit in the configuration control register. The device performs no additional action and continues to function. In this case, the nFAULT pin releases and OTW bit cleared when the die temperature decreases below the hysteresis point of the thermal warning (T_{OTW_HYS}). The OT bit remains latched until cleared through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}) and the die temperature is lower than thermal warning trip (T_{OTW}).

In hardware device variants, Over Temperature warning is not reported on nFAULT pin by default.

7.3.11.4.2 Thermal Shutdown (OTSD)

If the die temperature exceeds the trip point of the thermal shutdown limit (T_{OTS}), all the FETs are disabled, the charge pump is shut down, and the nFAULT pin is driven low. In addition, the FAULT and OT bit in the OT bit in the device status (DEV_STS1) register and OTSD bit in the OT_STS status register is set. Normal operation starts again (driver operation the nFAULT pin is released and OTSD bit cleared) when the overtemperature condition clears and after the t_{RETRY} time elapses. The OT and FAUTL bits stays latched high indicating that a thermal event occurred until a clear fault command is issued either through the CLR_FLT bit or an nSLEEP reset pulse (t_{RST}). This protection feature cannot be disabled.

On hardware device variants the t_{RETRY} perios is fixed to fast retry time of 5ms

t_{RETRY} configuration for SPI device variant

- Slow retry time SLOW_TRETRY can be used for t_{RETRY} period by configuring OTSD_MODE to 00b
- Fast retry time FAST_TRETRY can be used for t_{RETRY} period by configuring OTSD_MODE to 01b

7.4 Device Functional Modes

7.4.1 Functional Modes

7.4.1.1 Sleep Mode

The nSLEEP pin manages the state of the DRV8311 family of devices. When the nSLEEP pin is low, the device goes to a low-power sleep mode. In sleep mode, all FETs are disabled, sense amplifiers are disabled, buck regualtor (if present) is disabled, the charge pump is disabled, the AVDD regulator is disabled, and the SPI bus is disabled. The t_{SLEEP} time must elapse after a falling edge on the nSLEEP pin before the device goes to sleep mode. The device comes out of sleep mode automatically if the nSLEEP pin is pulled high. The t_{WAKE} time must elapse before the device is ready for inputs.

In sleep mode and when $V_{VM} < V_{UVLO}$, all MOSFETs are disabled.

Note

During power up and power down of the device through the nSLEEP pin, the nFAULT pin is held low as the internal regulators are enable or disable. After the regulators have enabled or disabled, the nFAULT pin is automatically released. The duration that the nFAULT pin is low does not exceed the t_{SLEEP} or t_{WAKE} time.

7.4.1.2 Operating Mode

When the nSLEEP pin is high and the V_{VM} voltage is greater than the V_{UVLO} voltage, the device goes to operating mode. The t_{WAKE} time must elapse before the device is ready for inputs. In this mode the charge pump, AVDD regulator, Buck Regulator and SPI bus are active.

7.4.1.3 Fault Reset (CLR_FLT or nSLEEP Reset Pulse)

In the case of device latched faults, the DRV8311 family of devices goes to a partial shutdown state to help protect the power MOSFETs and system.

When the fault condition clears, the device can go to the operating state again by either setting the CLR_FLT SPI bit on SPI devices or issuing a reset pulse to the nSLEEP pin on either interface variant. The nSLEEP reset pulse (t_{RST}) consists of a high-to-low-to-high transition on the nSLEEP pin. The low period of the sequence should fall with the t_{RST} time window or else the device will start the complete shutdown sequence. The reset pulse has no effect on any of the regulators, device settings, or other functional blocks

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7.5 SPI Communication

7.5.1 Programming

7.5.1.1 SPI and tSPI Format

SPI Format - with Parity

The SDI input data word is 24 bits long and consists of the following format:

- 1 read or write bit, W (bit B23)
- 6 address bits, A (bits B22 through B17)
- Parity bit, P (bit B16)
- 15 data bits with 1 parity bit, D (bits B15 through B0)

The SDO output data word is 24 bits long. The first 8 bits are status bits and the last 16 bits are the data content of the register being accessed.

Table 7-7. SDI Input Data Word Format for SPI

R/W	ADDRESS							PARITY	PARITY	DATA												
B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B9	B8	B7	B6	B5	B4	B3	B2	B1	B0
W0	A5	A4	A3	A2	A1	A0	P	P	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0

Table 7-8. SDO Output Data Word Format

STATUS								DATA															
B23	B22	B21	B20	B19	B18	B17	B16	B15	B14	B13	B12	B11	B10	B9	B8	B7	B6	B5	B4	B3	B2	B1	B0
S7	S6	S5	S4	S3	S2	S1	S0	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0

tSPI Format - with Parity

The SDI input data word is 32 bits long and consists of the following format:

- 1 read or write bit, W (bit B31)
- 4 secondary device ID bits, AD (bits B30 through B27)
- 8 address bits, A (bits B26 through B19)
- 2 reserved bits, 0 (bits B18, bit B17)
- Parity bit, P (bit B16)
- 15 data bits with 1 parity bit, D (bits B15 through B0)

The SDO output data word is 24 bits long. The first 8 bits are status bits and the last 16 bits are the data content of the register being accessed. The format is same as standard SPI shown in Table 7-8

Table 7-9. tSPI with Parity - SDI Input Data Word Format

R/W	Secondary device ID				ADDRESS	00		PARITY	PARITY	DATA
B31	B30	B29	B28	B27	B26 - B19	B18	B17	B16	B15	B14 - B0
W0	0	0	AD1	AD0	A7 - A0	0	0	P	P	D14 - D0

The details of the bits used in SPI and tSPI frame format are detailed below.

Read/Write Bit (R/W) : R/W (W0) bit being 0 indicates a SPI/tSPI Write transaction. For a read operation RW bit needs to be 1.

Secondary device ID Bits (AD) : Each tSPI secondary device on the same chip select should have a unique identifier. Secondary device ID field is the 4-bit unique identifier of the tSPI secondary device. For a successful Read/Write transaction the secondary device ID field should match with the secondary device address. In DRV8311 the two most significant bits of secondary device addresses are set to 00. The least two significant bits of the secondary device address can be configured using the AD1 and AD0 pins. The secondary device address 15 (0xF) is reserved for general call, all the devices on the same bus accept a write operation when

the secondary device ID field is set to 15. Hence the valid tSPI secondary device addresses for DRV8311 range from 0 to 3 and 15 (general call address).

Address Bits (A) : A tSPI secondary device takes 8-bit register address whereas SPI secondary device takes 6-bit register address. Each tSPI secondary device has two dedicated 8-bit address pointers, one for read and one for write. During a sequential read transaction, the read address pointer gets incremented automatically.During a sequential write transaction, both write address pointer and read address pointer will be incremented automatically.

Parity Bit (P) : Both header and data fields of a SPI/tSPI input data frame include a parity bit for single bit error detection. The parity scheme used is even parity i.e., the number of ones in a block of 16-bits (including the parity bit) is even. Data will be written to the internal registers only if the parity check is successful. During a read operation, the tSPI secondary device inserts a parity bit at the MSB of read data. Parity checks can be enabled or disabled by configuring the SPI_PEN bit of SYS_CTRL register. Parity checks are disabled by default.

Note

Though parity checks are disabled by default, TI recommends enabling parity checks to safeguard against single-bit errors.

Error Handling

Parity Error: Upon detecting a parity error, the secondary device responds in the following ways. Parity error gets latched and reported on nFAULT. The error status is available for read on SPI_PARITY field of SYS_STS register. A parity error in the header will not prevent the secondary device from responding with data. The SDO will be driven by the secondary device being addressed. Updates to write address pointer and the device registers will be ignored when parity error is detected. In a sequential write, upon detection of parity error any subsequent register writes will be ignored.

Frame Error :Any incomplete tSPI Frame will be reported as Frame error. If the number of tSPI clock cycles is not a multiple of 16, then the transfer is considered to be incomplete. Frame errors will be latched in FRM_ERR field of SYS_STS register and indicated on nFAULT.

SPI Read / Write Sequence

SPI Read Sequence: The SPI read transaction comprises of an 8-bit header (R/W - 1 bit, Address - 6 bits, and party -1 bit) followed by 16-bit dummy data words. Upon receiving the first byte of header, the secondary device responds with an 8-bit device status information. The read address pointer gets updated immediately after receiving the address field of the header. The read address from the header acts as the starting address for the register reads. The read address pointer gets incremented automatically upon completion of a 16-bit transfer. The length of data transfer is not restricted by the secondary device. The secondary device responds with data as long as the primary device transmits dummy words. If parity error check is enabled, the MSB of read data will be replaced with computed parity bit

SPI Write Sequence: SPI write transaction comprises of an 8-bit header followed by 16-bit data words to be written into the register bank. Similar to a read transaction, the addressed secondary device responds with an 8-bit device status information upon receiving the first byte of header. Once the header bytes are received, the write address pointer gets updated. The write address from the header acts as the starting address for sequential register writes. The read address pointer will retain the address of the register being read in the previous tSPI transaction. The length of data transfer is not restricted by the secondary device. Both read and write address pointers will be incremented automatically upon completion of a 16-bit transfer. While receiving data from the primary device, the SDO will be driven with the register data addressed by read address pointer.

tSPI Communication Sequence

The tSPI interface is similar to regular SPI interface in functionality but add support for multiple devices under the same Chip Select (nSCS). Any existing SPI primary device would be able to communicate with the tSPI secondary devices with modifications in the frame format.A valid tSPI frame must meet the following conditions (similar to SPI interface):

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- The SCLK pin should be low when the nSCS pin transitions from high to low and from low to high. A high to low transition at the nSCS pin is the start of frame and a low to high transition is the end of the frame.
- When the nSCS pin is pulled high, any signals at the SCLK and SDI pins are ignored and the SDO pin is placed in the Hi-Z state.
- Data is captured on the falling edge of the SCLK signal and data is driven on the rising edge of the SCLK signal.
- The most significant bit (MSB) is shifted in and out first.
- A minimum of 16 SCLK cycles must occur for transaction to be valid & the number of SCLK cycles in a single transaction must me a multiple of 16.
- If the data word sent to the SDI pin is not a multiple of 16 bits, a frame error occurs and the excess SCLK cycles are ignored.

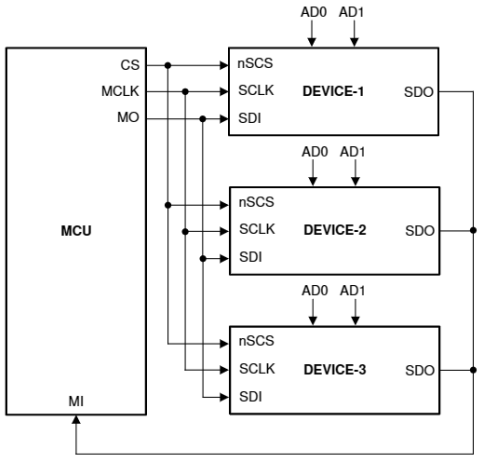

Figure 7-34. tSPI Block Diagram with Multiple Devices on Same Chip Select

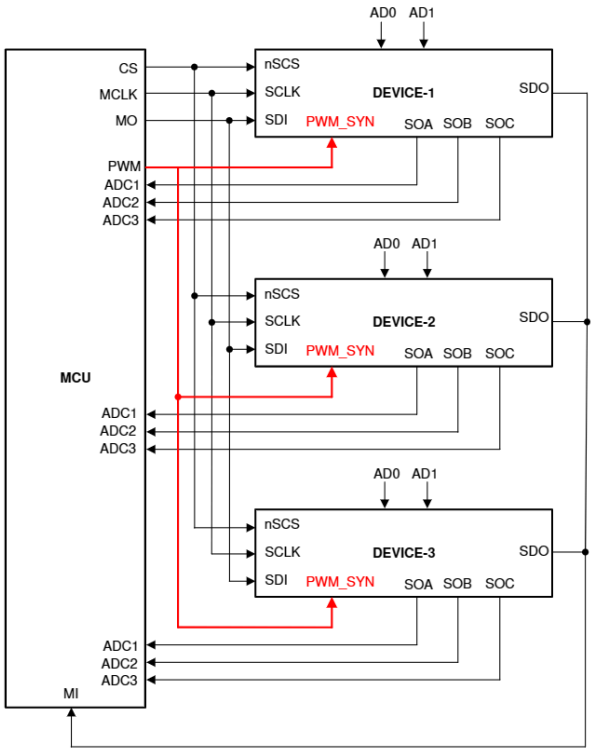

Figure 7-35. tSPI with PWM_SYNC

tSPI Read Sequence: A tSPI read transaction has a 16-bit header (R/W - 1 bit, Secondary device ID - 4 bits, Address - 8 bits, reserved -2 bits and party -1 bit) followed by 16-bit dummy data words. Upon receiving the first byte of header, the secondary device being addressed with matching secondary device ID field (configured using AD0 and and AD1 pins), responds with an 8-bit device status information. The read address from the header acts as the starting address for the register reads. The address gets incremented automatically upon completion of a 16-bit transfer. The length of data transfer is not restricted by the secondary device. The secondary device responds with data as long as the primary device transmits dummy words. If parity error check is enabled, the MSB of read data will be replaced with computed parity bit.

tSPI Write Sequence: A tSPI write transaction has a 16-bit header followed by 16-bit data words to be written into the register bank. Similar to a read transaction, the addressed secondary device responds with an 8-bit device status information upon receiving the first byte of header. The write address from the header acts as the starting address for sequential register writes. The length of data transfer is not restricted by the secondary device. Both write and read address pointers will be incremented automatically upon completion of a 16-bit transfer. While receiving data from the primary device, the SDO will be driven with the register data addressed by read address pointer

tSPI Read Address Update Sequence: The independent read and write address pointers in the secondary device would allow reading data from one set of registers while writing data to another set of registers. To achieve this, the primary device should first send a read address update frame before the tSPI write transaction. A read address frame is nothing but just the tSPI read sequence with just the header. The first tSPI transaction

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updates the read address pointer to desired register address. The second tSPI transaction is a register write sequence. During this sequence, the data send on SDO by the secondary device will be from the register pointed by read address pointer which was initialised in the previous tSPI read sequence.

The tSPI read/write sequence with parity is shown in Figure 7-36. The SPI frame header is marked as CMD[15:8] and CMD[7:0].

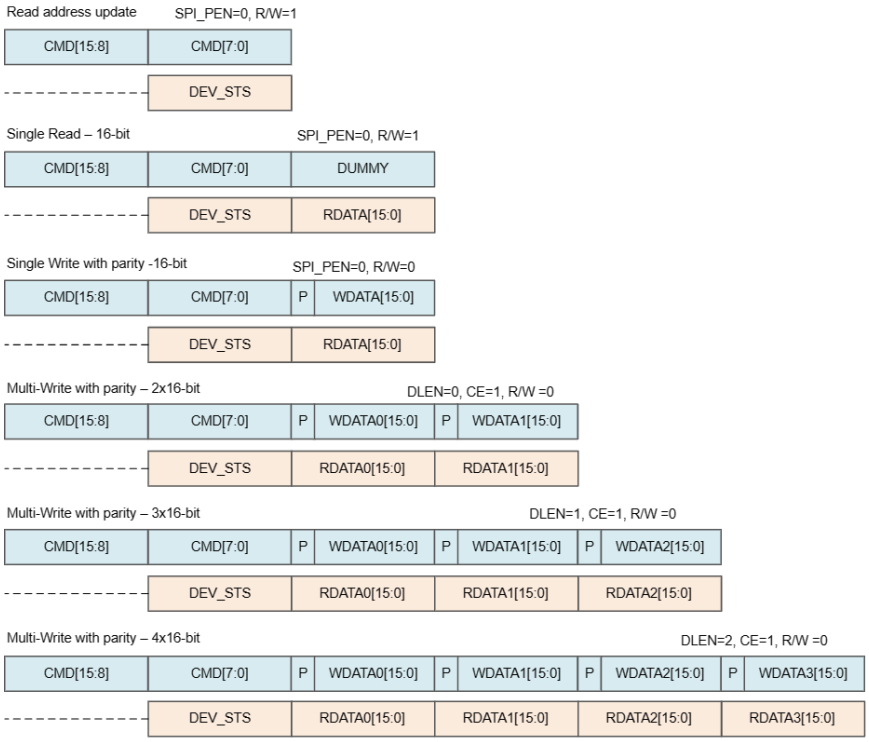

Figure 7-36. tSPI Read/Write with Partiy

8 DRV8311 Registers

DRV8311 Registers lists the memory-mapped registers for the DRV8311 registers. All register offset addresses not listed in DRV8311 Registers should be considered as reserved locations and the register contents should not be modified.

Table 8-1. DRV8311 Registers

Offset	Acronym	Register Name	Section
0h	DEV_STS1	Device Status 1 Register	Section 8.1
4h	OT_STS	Over Temperature Status Register	Section 8.2
5h	SUP_STS	Supply Status Register	Section 8.3
6h	DRV_STS	Driver Status Register	Section 8.4
7h	SYS_STS	System Status Register	Section 8.5
Ch	PWM_SYNC_PRD	PWM Sync Period Register	Section 8.6
10h	FLT_MODE	Fault Mode Register	Section 8.7
12h	SYSF_CTRL	System Fault Control Register	Section 8.8
13h	DRVF_CTRL	Drviver Fault Control Register	Section 8.9
16h	FLT_TCTRL	Fault Timing Control Register	Section 8.10
17h	FLT_CLR	Fault Clear Register	Section 8.11
18h	PWMG_PERIOD	PWM_GEN Period Register	Section 8.12
19h	PWMG_A_DUTY	PWM_GEN A Duty Register	Section 8.13
1Ah	PWMG_B_DUTY	PWM_GEN B Duty Register	Section 8.14
1Bh	PWMG_C_DUTY	PWM_GEN C Duty Register	Section 8.15
1Ch	PWM_STATE	PWM State Register	Section 8.16
1Dh	PWMG_CTRL	PWM_GEN Control Register	Section 8.17
20h	PWM_CTRL1	PWM Control Register 1	Section 8.18
22h	DRV_CTRL	Predriver control Register	Section 8.19
23h	CSA_CTRL	CSA Control Register	Section 8.20
3Fh	SYS_CTRL	System Control Register	Section 8.21

Complex bit access types are encoded to fit into small table cells. DRV8311 Access Type Codes shows the codes that are used for access types in this section.

Table 8-2. DRV8311 Access Type Codes

Access Type	Code	Description
Read Type		
R	R	Read
R-0	R -0	Read Returns 0s
Write Type		
W	W	Write
Reset or Default Value		
-n		Value after reset or the default value

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8.1 DEV_STS1 Register (Offset = 0h) [Reset = 0080h]

DEV_STS1 is shown in DEV_STS1 Register and described in DEV_STS1 Register Field Descriptions.

Return to the DRV8311 Registers.

Device Status 1 Register

Figure 8-1. DEV_STS1 Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						OTP_FLT
R-0h	R-0-0h						R-0h
7	6	5	4	3	2	1	0
RESET	SPI_FLT	OCP	RESERVED		UVP	OT	FAULT
R-1h	R-0h	R-0h	R-0h		R-0h	R-0h	R-0h

Table 8-3. DEV_STS1 Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-9	RESERVED	R-0	0h	Reserved
8	OTP_FLT	R	0h	OTP read fault 0h = No OTP read fault is detected 1h = OTP read fault detected
7	RESET	R	1h	Supply Power On Reset Status 0h = No power on reset condition is detected 1h = Power-on-reset condition is detected
6	SPI_FLT	R	0h	SPI Fault Status 0h = No SPI communication fault is detected 1h = SPI communication fault is detected
5	OCP	R	0h	Driver Overcurrent Protection Status 0h = No overcurrent condition is detected 1h = Overcurrent condition is detected
4-3	RESERVED	R	0h	Reserved
2	UVP	R	0h	Supply Undervoltage Status 0h = No undervoltage voltage condition is detected on CP, AVDD or VIN_AVDD 1h = Undervoltage voltage condition is detected on CP, AVDD or VIN_AVDD
1	OT	R	0h	Overtemperature Fault Status 0h = No overtemperature warning / shutdown is detected 1h = Overtemperature warning / shutdown is detected
0	FAULT	R	0h	Device Fault Status 0h = No fault condition is detected 1h = Fault condition is detected

8.2 OT_STS Register (Offset = 4h) [Reset = 0000h]

OT_STS is shown in OT_STS Register and described in OT_STS Register Field Descriptions.

Return to the DRV8311 Registers.

Over Temperature Status Register

Figure 8-2. OT_STS Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED					OTS_AVDD	OTW	OTSD
R-0-0h					R-0h	R-0h	R-0h

Table 8-4. OT_STS Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-3	RESERVED	R-0	0h	Reserved
2	OTS_AVDD	R	0h	AVDD LDO Overtemperature Fault Status 0h = No overtemperature shutdown near AVDD is detected 1h = Overtemperature shutdown near AVDD is detected
1	OTW	R	0h	Overtemperature Warning Status 0h = No overtemperature warning is detected 1h = Overtemperature warning is detected
0	OTSD	R	0h	Overtemperature Shutdown Fault Status 0h = No overtemperature shutdown is detected 1h = Overtemperature shutdown is detected

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8.3 SUP_STS Register (Offset = 5h) [Reset = 0000h]

SUP_STS is shown in SUP_STS Register and described in SUP_STS Register Field Descriptions.

Return to the DRV8311 Registers.

Supply Status Register

Figure 8-3. SUP_STS Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED		CSAREF_UV	CP_UV	RESERVED	AVDD_UV	RESERVED	VINAVDD_UV
R-0-0h		R-0h	R-0h	R-0-0h	R-0h	R-0-0h	R-0h

Table 8-5. SUP_STS Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-6	RESERVED	R-0	0h	Reserved
5	CSAREF_UV	R	0h	CSA REF Undervoltage Fault Status 0h = No CSAREF undervoltage is detected 1h = CSAREF undervoltage is detected
4	CP_UV	R	0h	Charge Pump Undervoltage Fault Status 0h = No charge pump undervoltage is detected 1h = Charge pump undervoltage is detected
3	RESERVED	R-0	0h	Reserved
2	AVDD_UV	R	0h	AVDD LDO Undervoltage Fault Status 0h = No AVDD ouput undervoltage is detected 1h = AVDD ouput undervoltage is detected
1	RESERVED	R-0	0h	Reserved
0	VINAVDD_UV	R	0h	VIN_AVDD Undervoltage Fault Status 0h = No AVDD supply input undervoltage is detected 1h = AVDD supply input undervoltage is detected

8.4 DRV_STS Register (Offset = 6h) [Reset = 0000h]

DRV_STS is shown in DRV_STS Register and described in DRV_STS Register Field Descriptions.

Return to the DRV8311 Registers.

Driver Status Register

Figure 8-4. DRV_STS Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED	OCPC_HS	OCPB_HS	OCPA_HS	RESERVED	OCPC_LS	OCPB_LS	OCPA_LS
R-0-0h	R-0h	R-0h	R-0h	R-0-0h	R-0h	R-0h	R-0h

Table 8-6. DRV_STS Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-7	RESERVED	R-0	0h	Reserved
6	OCPC_HS	R	0h	Overcurrent Status on High-side MOSFET of OUTC 0h = No overcurrent detected on high-side MOSFET of OUTC 1h = Overcurrent detected on high-side MOSFET of OUTC
5	OCPB_HS	R	0h	Overcurrent Status on High-side MOSFET of OUTB 0h = No overcurrent detected on high-side MOSFET of OUTB 1h = Overcurrent detected on high-side MOSFET of OUTB
4	OCPA_HS	R	0h	Overcurrent Status on High-side MOSFET of OUTA 0h = No overcurrent detected on high-side MOSFET of OUTA 1h = Overcurrent detected on high-side MOSFET of OUTA
3	RESERVED	R-0	0h	Reserved
2	OCPC_LS	R	0h	Overcurrent Status on Low-side MOSFET of OUTC 0h = No overcurrent detected on low-side MOSFET of OUTC 1h = Overcurrent detected on low-side MOSFET of OUTC
1	OCPB_LS	R	0h	Overcurrent Status on Low-side MOSFET of OUTB 0h = No overcurrent detected on low-side MOSFET of OUTB 1h = Overcurrent detected on low-side MOSFET of OUTB
0	OCPA_LS	R	0h	Overcurrent Status on Low-side MOSFET of OUTA 0h = No overcurrent detected on low-side MOSFET of OUTA 1h = Overcurrent detected on low-side MOSFET of OUTA

8.5 SYS_STS Register (Offset = 7h) [Reset = 0000h]

SYS_STS is shown in SYS_STS Register and described in SYS_STS Register Field Descriptions.

Return to the DRV8311 Registers.

System Status Register

Figure 8-5. SYS_STS Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED			OTPLD_ERR	RESERVED	SPI_PARITY	BUS_CNT	FRM_ERR
R-0-0h			R-0h	R-0-0h	R-0h	R-0h	R-0h

Table 8-7. SYS_STS Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-5	RESERVED	R-0	0h	Reserved
4	OTPLD_ERR	R	0h	OTP Read Error 0h = No OTP read error is detected 1h = OTP read error is detected
3	RESERVED	R-0	0h	Reserved
2	SPI_PARITY	R	0h	SPI Parity Error 0h = No SPI Parity Error is detected 1h = SPI Parity Error is detected
1	BUS_CNT	R	0h	SPI Bus Contention Error 0h = No SPI Bus Contention Error is detected 1h = SPI Bus Contention Error is detected
0	FRM_ERR	R	0h	SPI Frame Error 0h = No SPI Frame Error is detected 1h = SPI Frame Error is detected

8.6 PWM_SYNC_PRD Register (Offset = Ch) [Reset = 0000h]

PWM_SYNC_PRD is shown in PWM_SYNC_PRD Register and described in PWM_SYNC_PRD Register Field Descriptions.

Return to the DRV8311 Registers.

PWM Sync Period Register

Figure 8-6. PWM_SYNC_PRD Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED			PWM_SYNC_PRD			
R-0h	R-0-0h			R-0h			
7	6	5	4	3	2	1	0
PWM_SYNC_PRD							
R-0h							

Table 8-8. PWM_SYNC_PRD Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-12	RESERVED	R-0	0h	Reserved
11-0	PWM_SYNC_PRD	R	0h	12-bit output indicating period of PWM_SYNC signal

8.7 FLT_MODE Register (Offset = 10h) [Reset = 0000h]

FLT_MODE is shown in FLT_MODE Register and described in FLT_MODE Register Field Descriptions.

Return to the DRV8311 Registers.

Fault Mode Register

Figure 8-7. FLT_MODE Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						OTPFLT_MODE
R-0h	R-0-0h						R/W-0h
7	6	5	4	3	2	1	0
SPIFLT_MODE	OCP_MODE			UVP_MODE		OTSD_MODE	
R/W-0h	R/W-0h			R/W-0h		R/W-0h	

Table 8-9. FLT_MODE Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-9	RESERVED	R-0	0h	Reserved
8	OTPFLT_MODE	R/W	0h	System Fault Mode. 0h = OTP read fault is enabled 1h = OTP read fault is disabled
7	SPIFLT_MODE	R/W	0h	SPI Fault mode 0h = SPI Fault is enabled 1h = SPI Fault is disabled
6-4	OCP_MODE	R/W	0h	Overcurrent Protection Fault mode 0h = Report on nFault, predriver HiZ, auto recovery with Slow Retry time (in ms) 1h = Report on nFault, predriver HiZ, auto recovery with Fast Retry time (in ms) 2h = Report on nFault, predriver HiZ, Latched Fault 3h = Report on nFault, No action on predriver 4h = Reserved 5h = Reserved 6h = Reserved 7h = Disabled
3-2	UVP_MODE	R/W	0h	Undervoltage Protection Fault mode 0h = Report on nFault, predriver HiZ, auto recovery with Slow Retry time (in ms) 1h = Report on nFault, redriver HiZ, auto recovery with Fast Retry time (in ms) 2h = Reserved 3h = Reserved
1-0	OTSD_MODE	R/W	0h	Overtemperature Fault mode 0h = Report on nFault, predriver HiZ, auto recovery with Slow Retry time (in ms) 1h = Report on nFault, predriver HiZ, auto recovery with Fast Retry time (in ms) 2h = Reserved 3h = Reserved

8.8 SYSF_CTRL Register (Offset = 12h) [Reset = 0735h]

SYSF_CTRL is shown in SYSF_CTRL Register and described in SYSF_CTRL Register Field Descriptions.

Return to the DRV8311 Registers.

System Fault Control Register

Figure 8-8. SYSF_CTRL Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED				OTAVDD_EN	OTW_EN	RESERVED
R-0h	R-0-0h				R/W-1h	R/W-1h	R-0-4h
7	6	5	4	3	2	1	0
RESERVED		CSAVREFUV_EN	RESERVED	RESERVED	RESERVED	RESERVED	RESERVED
R-0-4h		R/W-1h	R/W-1h	R-0-0h	R/W-1h	R-0-0h	R/W-1h

Table 8-10. SYSF_CTRL Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-11	RESERVED	R-0	0h	Reserved
10	OTAVDD_EN	R/W	1h	AVDD Overtemperature Fault Enable 0h = Overtemperature protection near AVDD is disabled 1h = Overtemperature protection near AVDD is enabled
9	OTW_EN	R/W	1h	Overtemperature Warning Fault Enable 0h = Over temperature warning reporting on nFAULT is disabled 1h = Over temperature warning reporting on nFAULT is enabled
8-6	RESERVED	R-0	4h	Reserved
5	CSAVREFUV_EN	R/W	1h	CSAREF Undervoltage Fault Enable 0h = CSAREF undervoltage lockout is disabled 1h = CSAREF undervoltage lockout is enabled
4	RESERVED	R/W	1h	Reserved
3	RESERVED	R-0	0h	Reserved
2	RESERVED	R/W	1h	Reserved
1	RESERVED	R-0	0h	Reserved
0	RESERVED	R/W	1h	Reserved

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8.9 DRVF_CTRL Register (Offset = 13h) [Reset = 0000h]

DRVF_CTRL is shown in DRVF_CTRL Register and described in DRVF_CTRL Register Field Descriptions.

Return to the DRV8311 Registers.

Drviver Fault Control Register

Figure 8-9. DRVF_CTRL Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED		OCP_DEG		OCP_TBLANK		RESERVED	OCP_LVL
R-0-0h		R/W-0h		R/W-0h		R-0-0h	R/W-0h

Table 8-11. DRVF_CTRL Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-6	RESERVED	R-0	0h	Reserved
5-4	OCP_DEG	R/W	0h	OCP Deglitch time 0h = OCP deglitch time is 0.2 µs 1h = OCP deglitch time is 0.5 µs 2h = OCP deglitch time is 0.8 µs 3h = OCP deglitch time is 1 µs
3-2	OCP_TBLANK	R/W	0h	OCP Blanking time 0h = OCP blanking time is 0.2 µs 1h = OCP blanking time is 0.5 µs 2h = OCP blanking time is 0.8 µs 3h = OCP blanking time is 1 µs
1	RESERVED	R-0	0h	Reserved
0	OCP_LVL	R/W	0h	OCP Level Settings 0h = OCP level is 9 A (TYP) 1h = OCP level is 5 A (TYP)

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8.10 FLT_TCTRL Register (Offset = 16h) [Reset = 0005h]

FLT_TCTRL is shown in FLT_TCTRL Register and described in FLT_TCTRL Register Field Descriptions.

Return to the DRV8311 Registers.

Fault Timing Control Register

Figure 8-10. FLT_TCTRL Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED				SLOW_TRETRY		FAST_TRETRY	
R-0-0h				R/W-1h		R/W-1h	

Table 8-12. FLT_TCTRL Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-4	RESERVED	R-0	0h	Reserved
3-2	SLOW_TRETRY	R/W	1h	Slow Recovery Retry Time from Fault Condition 0h = 0.5s 1h = 1s 2h = 2s 3h = 5s
1-0	FAST_TRETRY	R/W	1h	Fast Recovery Retry Time from Fault Condition 0h = 0.5ms 1h = 1ms 2h = 2ms 3h = 5ms

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8.11 FLT_CLR Register (Offset = 17h) [Reset = 0000h]

FLT_CLR is shown in FLT_CLR Register and described in FLT_CLR Register Field Descriptions.

Return to the DRV8311 Registers.

Fault Clear Register

Figure 8-11. FLT_CLR Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED							FLT_CLR
R-0-0h							W-0h

Table 8-13. FLT_CLR Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-1	RESERVED	R-0	0h	Reserved
0	FLT_CLR	W	0h	Clear Fault 0h = No clear fault command is issued 1h = To clear the latched fault bits. This bit automatically resets after being written.

8.12 PWMG_PERIOD Register (Offset = 18h) [Reset = 0000h]

PWMG_PERIOD is shown in PWMG_PERIOD Register and described in PWMG_PERIOD Register Field Descriptions.

Return to the DRV8311 Registers.

PWM_GEN Period Register

Figure 8-12. PWMG_PERIOD Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED			PWM_PRD_OUT			
R-0h	R-0-0h			R/W-0h			
7	6	5	4	3	2	1	0
PWM_PRD_OUT							
R/W-0h							

Table 8-14. PWMG_PERIOD Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-12	RESERVED	R-0	0h	Reserved
11-0	PWM_PRD_OUT	R/W	0h	12-bit Period for output PWM signals in PWM Generation Mode

8.13 PWMG_A_DUTY Register (Offset = 19h) [Reset = 0000h]

PWMG_A_DUTY is shown in PWMG_A_DUTY Register and described in PWMG_A_DUTY Register Field Descriptions.

Return to the DRV8311 Registers.

PWM_GEN A Duty Register

Figure 8-13. PWMG_A_DUTY Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED			PWM_DUTY_OUTA			
R-0h	R-0-0h			R/W-0h			
7	6	5	4	3	2	1	0
PWM_DUTY_OUTA							
R/W-0h							

Table 8-15. PWMG_A_DUTY Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-12	RESERVED	R-0	0h	Reserved
11-0	PWM_DUTY_OUTA	R/W	0h	12-bit Duty Cycle for Phase A output in PWM Generation Mode

8.14 PWMG_B_DUTY Register (Offset = 1Ah) [Reset = 0000h]

PWMG_B_DUTY is shown in PWMG_B_DUTY Register and described in PWMG_B_DUTY Register Field Descriptions.

Return to the DRV8311 Registers.

PWM_GEN B Duty Register

Figure 8-14. PWMG_B_DUTY Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED			PWM_DUTY_OUTB			
R-0h	R-0-0h			R/W-0h			
7	6	5	4	3	2	1	0
PWM_DUTY_OUTB							
R/W-0h							

Table 8-16. PWMG_B_DUTY Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-12	RESERVED	R-0	0h	Reserved
11-0	PWM_DUTY_OUTB	R/W	0h	12-bit Duty Cycle for Phase B output in PWM Generation Mode

8.15 PWMG_C_DUTY Register (Offset = 1Bh) [Reset = 0000h]

PWMG_C_DUTY is shown in PWMG_C_DUTY Register and described in PWMG_C_DUTY Register Field Descriptions.

Return to the DRV8311 Registers.

PWM_GEN C Duty Register

Figure 8-15. PWMG_C_DUTY Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED			PWM_DUTY_OUTC			
R-0h	R-0-0h			R/W-0h			
7	6	5	4	3	2	1	0
PWM_DUTY_OUTC							
R/W-0h							

Table 8-17. PWMG_C_DUTY Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-12	RESERVED	R-0	0h	Reserved
11-0	PWM_DUTY_OUTC	R/W	0h	12-bit Duty Cycle for Phase C output in PWM Generation Mode

8.16 PWM_STATE Register (Offset = 1Ch) [Reset = 0777h]

PWM_STATE is shown in PWM_STATE Register and described in PWM_STATE Register Field Descriptions.

Return to the DRV8311 Registers.

PWM State Register

Figure 8-16. PWM_STATE Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED					PWMC_STATE	
R-0h	R-0-0h					R/W-7h	
7	6	5	4	3	2	1	0
RESERVED	PWMB_STATE			RESERVED		PWMA_STATE	
R-0-0h	R/W-7h			R-0-0h		R/W-7h	

Table 8-18. PWM_STATE Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-11	RESERVED	R-0	0h	Reserved
10-8	PWMC_STATE	R/W	7h	Phase C Driver Output control 0h = High Side is OFF, Low Side is OFF 1h = High Side is OFF, Low Side is forced ON 2h = High Side is forced ON, Low Side is OFF 3h = Reserved 4h = Reserved 5h = High Side is OFF, Low Side PWM 6h = High Side PWM, Low Side is OFF 7h = High Side PWM, Low Side IPWM
7	RESERVED	R-0	0h	Reserved
6-4	PWMB_STATE	R/W	7h	Phase B Driver Output control 0h = High Side is OFF, Low Side is OFF 1h = High Side is OFF, Low Side is forced ON 2h = High Side is forced ON, Low Side is OFF 3h = Reserved 4h = Reserved 5h = High Side is OFF, Low Side PWM 6h = High Side PWM, Low Side is OFF 7h = High Side PWM, Low Side IPWM
3	RESERVED	R-0	0h	Reserved
2-0	PWMA_STATE	R/W	7h	Phase A Driver Output control 0h = High Side is OFF, Low Side is OFF 1h = High Side is OFF, Low Side is forced ON 2h = High Side is forced ON, Low Side is OFF 3h = Reserved 4h = Reserved 5h = High Side is OFF, Low Side PWM 6h = High Side PWM, Low Side is OFF 7h = High Side PWM, Low Side IPWM

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8.17 PWMG_CTRL Register (Offset = 1Dh) [Reset = 0000h]

PWMG_CTRL is shown in PWMG_CTRL Register and described in PWMG_CTRL Register Field Descriptions.

Return to the DRV8311 Registers.

PWM_GEN Control Register

Figure 8-17. PWMG_CTRL Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED				PWM_EN	PWMCNTR_MODE	
R-0h	R-0-0h				R/W-0h	R/W-0h	
7	6	5	4	3	2	1	0
PWM_OSC_SYNC			SPICLK_FREQ_SYNC			SPISYNC_ACRCY	
R/W-0h			R/W-0h			R/W-0h	

Table 8-19. PWMG_CTRL Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-11	RESERVED	R-0	0h	Reserved
10	PWM_EN	R/W	0h	Enable 3X Internal mode PWM Generation 0h = PWM_GEN disabled 1h = PWM_GEN enabled
9-8	PWMCNTR_MODE	R/W	0h	PWM Gen counter mode 0h = Up and Down 1h = Up 2h = Down 3h = No action
7-5	PWM_OSC_SYNC	R/W	0h	Oscillator synchronization and PWM_SYNC control 0h = Oscillator synchronization is disable 1h = PWM_SYNC_PRD indicates period of PWM_SYNC signal and can be used to calibrate PWM period 2h = PWM_SYNC used to set PWM period 3h = Oscillator synchronization is disable 4h = Oscillator synchronization is disable 5h = PWM_SYNC used for oscillator synchronization (only 20 kHz frequency supported) 6h = PWM_SYNC used for oscillator synchronization and setting PWM period (only 20 kHz frequency supported) 7h = SPI Clock pin SCLK used for oscillator synchronization (Configure SPICLK_FREQ_SYNC)
4-2	SPICLK_FREQ_SYNC	R/W	0h	SPI Clock Frequency for synchronizing the Oscillator 0h = 1 MHz 1h = 1.25 MHz 2h = 2 MHz 3h = 2.5 MHz 4h = 4 MHz 5h = 5 MHz 6h = 8 MHz 7h = 10 MHz

Table 8-19. PWMG_CTRL Register Field Descriptions (continued)

Bit	Field	Type	Reset	Description
1-0	SPISYNC_ACRCY	R/W	0h	Number of SPI Clock Cycle require for synchronizing the Oscillator 0h = 512 Clock Cycles (1%) 1h = 256 Clock Cycles (1%) 2h = 128 Clock Cycles (1%) 3h = 64 Clock Cycles (2%)

8.18 PWM_CTRL1 Register (Offset = 20h) [Reset = 0003h]

PWM_CTRL1 is shown in PWM_CTRL1 Register and described in PWM_CTRL1 Register Field Descriptions.

Return to the DRV8311 Registers.

PWM Control Register 1

Figure 8-18. PWM_CTRL1 Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED					SSC_DIS	PWM_MODE	
R-0-0h					R/W-0h	R/W-3h	

Table 8-20. PWM_CTRL1 Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-3	RESERVED	R-0	0h	Reserved
2	SSC_DIS	R/W	0h	Disable Spread Spectrum Modulation for internal Oscillator 0h = Spread spectrum modulation is enabled 1h = Spread spectrum modulation is disabled
1-0	PWM_MODE	R/W	3h	PWM mode selection 0h = 6x mode 1h = 6x mode 2h = 3x mode 3h = PWM Generation mode

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8.19 DRV_CTRL Register (Offset = 22h) [Reset = 0000h]

DRV_CTRL is shown in DRV_CTRL Register and described in DRV_CTRL Register Field Descriptions.

Return to the DRV8311 Registers.

Predriver control Register

Figure 8-19. DRV_CTRL Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED			RESERVED			
R-0h	R-0-0h			R/W-0h			
7	6	5	4	3	2	1	0
DLYCMP_EN	TDEAD_CTRL			RESERVED		SLEW_RATE	
R/W-0h	R/W-0h			R-0-0h		R/W-0h	

Table 8-21. DRV_CTRL Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-12	RESERVED	R-0	0h	Reserved
11-8	RESERVED	R/W	0h	Reserved
7	DLYCMP_EN	R/W	0h	Driver Delay Compensation enable 0h = Driver Delay Compensation is disabled 1h = Driver Delay Compensation is enabled
6-4	TDEAD_CTRL	R/W	0h	Deadtime insertion control 0h = No deadtime (Handsake Only) 1h = 200ns 2h = 400ns 3h = 600ns 4h = 800ns 5h = 1us 6h = 1.2us 7h = 1.4us
3-2	RESERVED	R-0	0h	Reserved
1-0	SLEW_RATE	R/W	0h	Slew rate settings 0h = Slew rate is 35 V/µs 1h = Slew rate is 75 V/µs 2h = Slew rate is 180 V/µs 3h = Slew rate is 230 V/µs

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8.20 CSA_CTRL Register (Offset = 23h) [Reset = 0000h]

CSA_CTRL is shown in CSA_CTRL Register and described in CSA_CTRL Register Field Descriptions.

Return to the DRV8311 Registers.

CSA Control Register

Figure 8-20. CSA_CTRL Register

15	14	13	12	11	10	9	8
Parity_bit	RESERVED						
R-0h	R-0-0h						
7	6	5	4	3	2	1	0
RESERVED				CSA_EN	RESERVED	CSA_GAIN	
R-0-0h				R/W-0h	R-0-0h	R/W-0h	

Table 8-22. CSA_CTRL Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-4	RESERVED	R-0	0h	Reserved
3	CSA_EN	R/W	0h	Current Sense Amplifier Enable 0h = Current Sense Amplifier is disabled 1h = Current Sense Amplifier is enabled
2	RESERVED	R-0	0h	Reserved
1-0	CSA_GAIN	R/W	0h	Current Sense Amplifier Gain settings 0h = CSA gain is 0.25 V/A 1h = CSA gain is 0.5 V/A 2h = CSA gain is 1 V/A 3h = CSA gain is 2 V/A

8.21 SYS_CTRL Register (Offset = 3Fh) [Reset = 0000h]

SYS_CTRL is shown in SYS_CTRL Register and described in SYS_CTRL Register Field Descriptions.

Return to the DRV8311 Registers.

System Control Register

Figure 8-21. SYS_CTRL Register

15	14	13	12	11	10	9	8
Parity_bit	WRITE_KEY			RESERVED			RESERVED
R-0h	W-0h			R-0-0h			R/W-0h
7	6	5	4	3	2	1	0
REG_LOCK	SPI_PEN	RESERVED		RESERVED	RESERVED		
R/W-0h	R/W-0h	R/W-0h		R/W-0h	R/W-0h		

Table 8-23. SYS_CTRL Register Field Descriptions

Bit	Field	Type	Reset	Description
15	Parity_bit	R	0h	Parity Bit if SPI_PEN is set to '1' otherwise reserved
14-12	WRITE_KEY	W	0h	0x5 Write Key Specific to this register.
11-9	RESERVED	R-0	0h	Reserved
8	RESERVED	R/W	0h	Reserved
7	REG_LOCK	R/W	0h	Register Lock Bit 0h = Registers Unlocked 1h = Registers Locked
6	SPI_PEN	R/W	0h	Parity Enable for both SPI and tSPI 0h = Parity Disabled 1h = Parity Enabled
5-4	RESERVED	R/W	0h	Reserved
3	RESERVED	R/W	0h	Reserved
2-0	RESERVED	R/W	0h	Reserved

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9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The DRV8311 can be used to drive Brushless-DC motors.

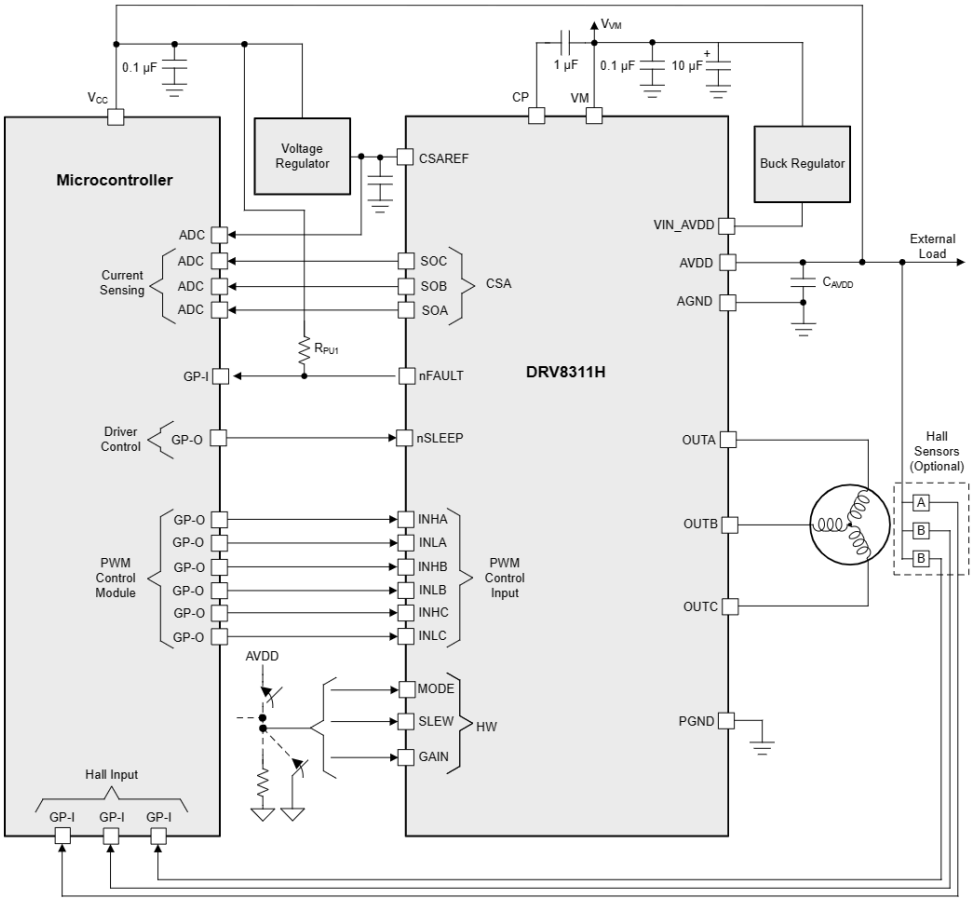

Figure 9-1. Application Schematics (DRV8311H)

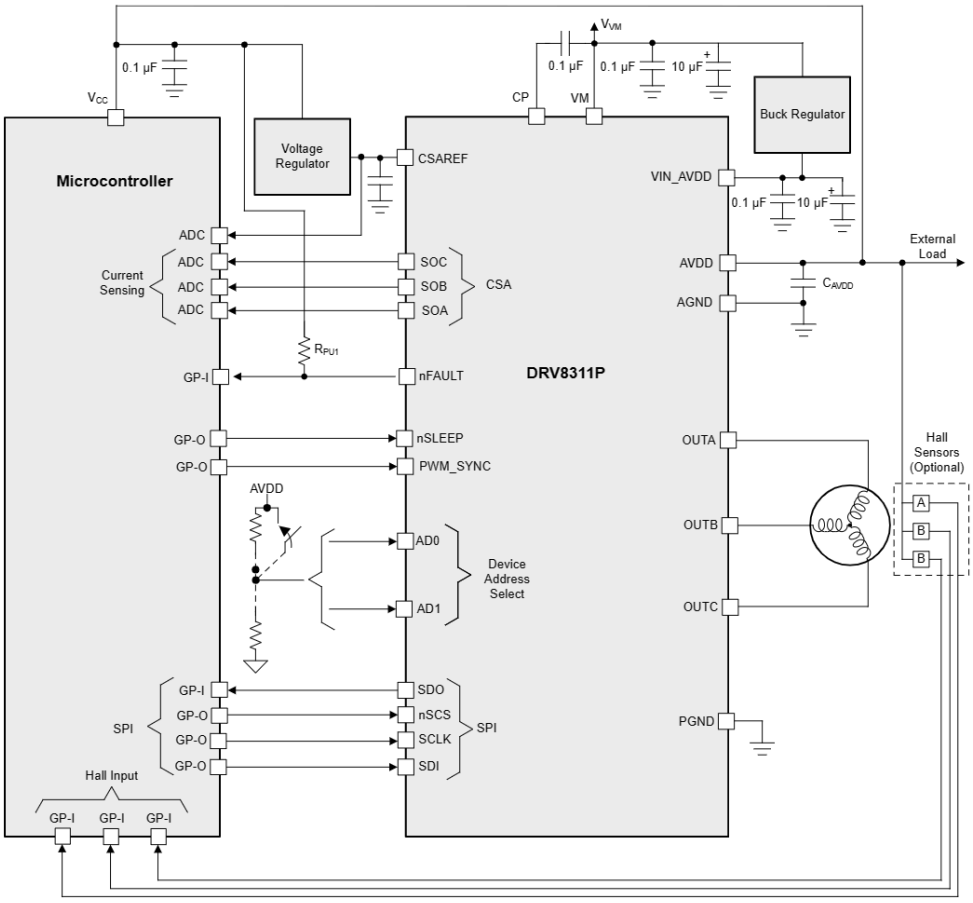

Figure 9-2. Application Schematics (DRV8311P)

ADVANCE INFORMATION

9.2 Typical Applications

9.2.1 Three-Phase Brushless-DC Motor Control

In this application, the DRV8311H is used to drive a Brushless-DC motor

9.2.1.1 Detailed Design Procedure

Table 9-1lists the example input parameters for the system design.

Table 9-1. Design Parameters

DESIGN PARAMETERS	REFERENCE	EXAMPLE VALUE
Supply voltage	V_{VM}	12 V
Motor RMS current	I_{RMS}	2 A
Motor peak current	I_{PEAK}	3 A
PWM Frequency	f_{PWM}	50 kHz
Slew Rate Setting	SR	230 V/µs
VIN_AVDD supply voltage	V_{VIN_AVDD}	12 V
CSA reference voltage	V_{CSA_REF}	3.0 V
System ambient temperature	T_A	–20°C to +105°C

9.2.1.1.1 Motor Voltage

Brushless-DC motors are typically rated for a certain voltage (for example 12 V). Operating a motor at a higher voltage corresponds to a lower drive current to obtain the same motor power. A higher operating voltage also corresponds to a higher obtainable rpm. DRV8311 device allows for the use of higher operating voltage because of a maximum VM rating of 20 V.

Operating at lower voltages generally allows for more accurate control of phase currents. The DRV8311 functions down to a supply of 3 V.

10 Power Supply Recommendations

10.1 Bulk Capacitance

Having an appropriate local bulk capacitance is an important factor in motor drive system design. It is generally beneficial to have more bulk capacitance, while the disadvantages are increased cost and physical size.

The amount of local capacitance needed depends on a variety of factors, including:

- The highest current required by the motor system
- The capacitance and current capability of the power supply
- The amount of parasitic inductance between the power supply and motor system
- The acceptable voltage ripple
- The type of motor used (brushed dc, brushless DC, stepper)
- The motor braking method

The inductance between the power supply and the motor drive system limits the rate current can change from the power supply. If the local bulk capacitance is too small, the system responds to excessive current demands or dumps from the motor with a change in voltage. When adequate bulk capacitance is used, the motor voltage remains stable and high current can be quickly supplied.

The data sheet generally provides a recommended value, but system-level testing is required to determine the appropriate sized bulk capacitor.

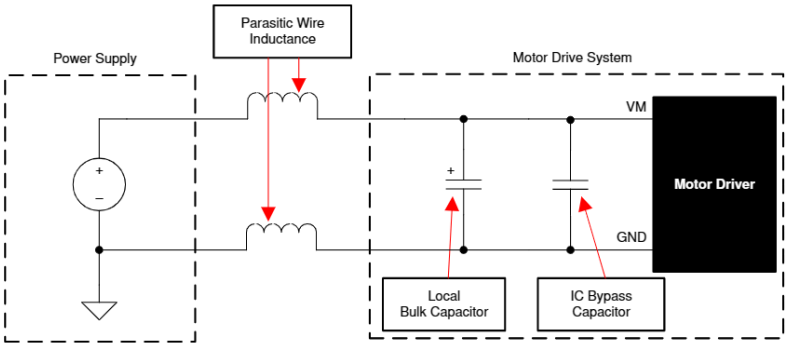

Figure 10-1. Example Setup of Motor Drive System With External Power Supply

The voltage rating for bulk capacitors should be higher than the operating voltage, to provide margin for cases when the motor transfers energy to the supply.

ADVANCE INFORMATION

11 Layout

11.1 Layout Guidelines

The bulk capacitor should be placed to minimize the distance of the high-current path through the motor driver device. The connecting metal trace widths should be as wide as possible, and numerous vias should be used when connecting PCB layers. These practices minimize inductance and allow the bulk capacitor to deliver high current.

Small-value capacitors should be ceramic, and placed closely to device pins.

The high-current device outputs should use wide metal traces.

The device thermal pad should be soldered to the PCB top-layer ground plane. Multiple vias should be used to connect to a large bottom-layer ground plane. The use of large metal planes and multiple vias helps dissipate the $I^2 \times r_{DS(on)}$ heat that is generated in the device.

11.2 Layout Example

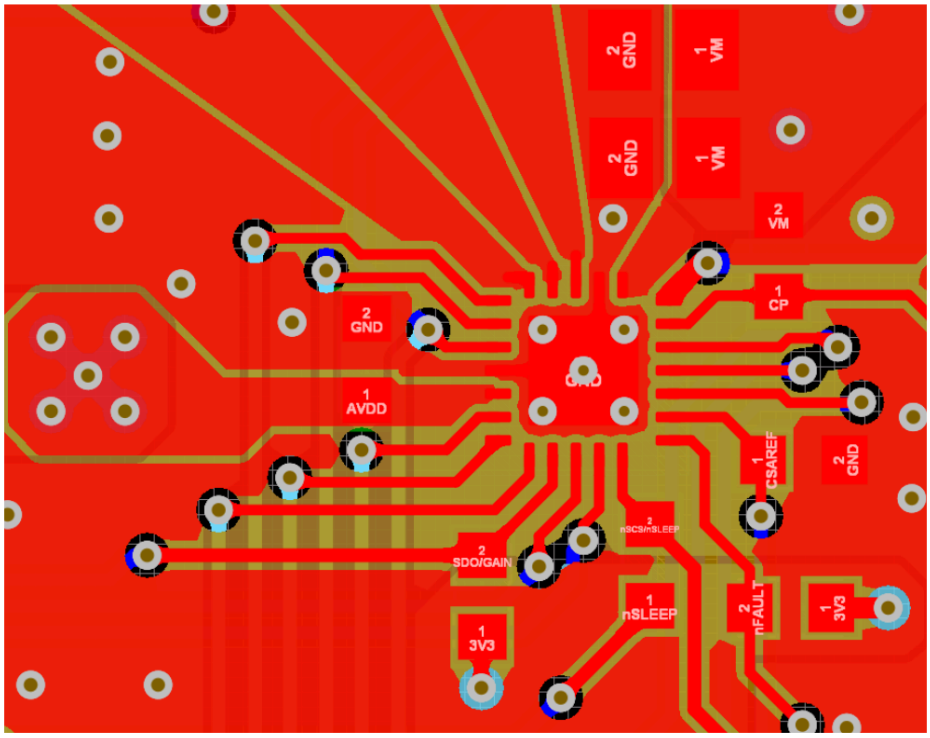

Figure 11-1. Recommended Layout Example for DRV8311

ADVANCE INFORMATION

11.3 Thermal Considerations

The DRV8311 has thermal shutdown (TSD) as previously described. A die temperature in excess of 150°C (minimally) disables the device until the temperature drops to a safe level.

Any tendency of the device to enter thermal shutdown is an indication of excessive power dissipation, insufficient heatsinking, or too high an ambient temperature.

11.3.1 Power Dissipation

The power dissipated in the output FET resistance, or $r_{DS(on)}$ dominates power dissipation in the DRV8311. A rough estimate of average power dissipation of each half-H-bridge when running a static load is:

At start-up and fault conditions, this current is much higher than normal running current; remember to take these peak currents and their duration into consideration.

The total device dissipation is the power dissipated in each of the three half-H-bridges added together.

The maximum amount of power that the device can dissipate depends on ambient temperature and heatsinking.

Note that $r_{DS(on)}$ increases with temperature, so as the device heats, the power dissipation increases. Take this into consideration when sizing the heatsink.

12 Device and Documentation Support

12.1 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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12.2 Trademarks

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12.3 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.4 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most-current data available for the designated device. This data is subject to change without notice and without revision of this document. For browser-based versions of this data sheet, see the left-hand navigation pane.

ADVANCE INFORMATION

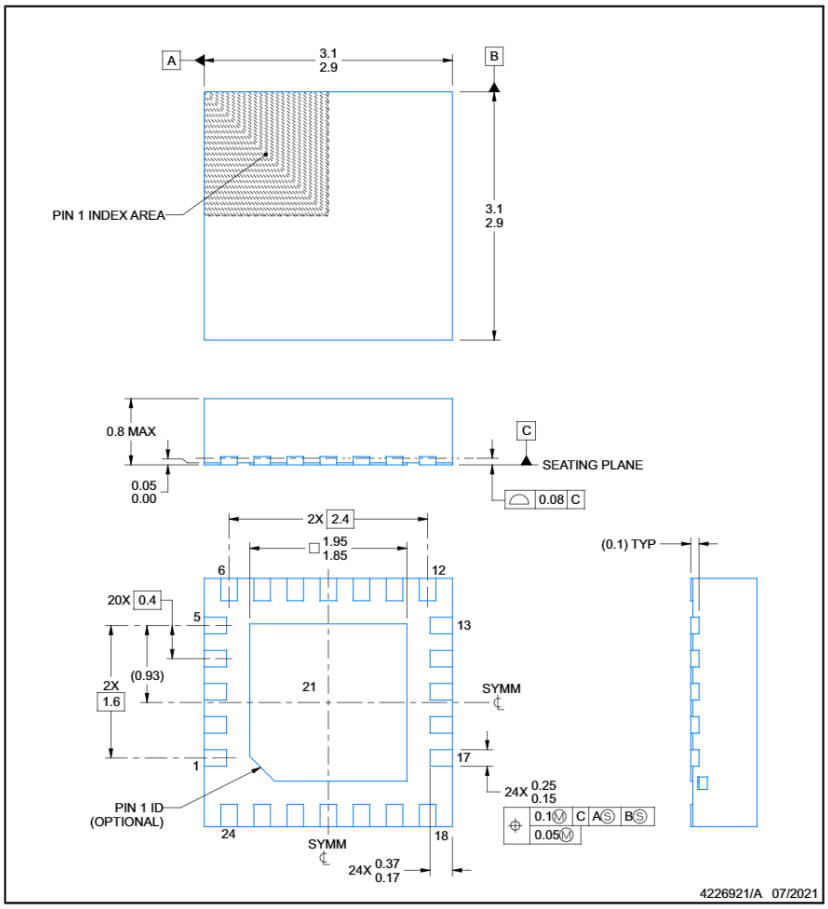
ADVANCE INFORMATION

PACKAGE OUTLINE

RRW0024A

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

Texas Instruments
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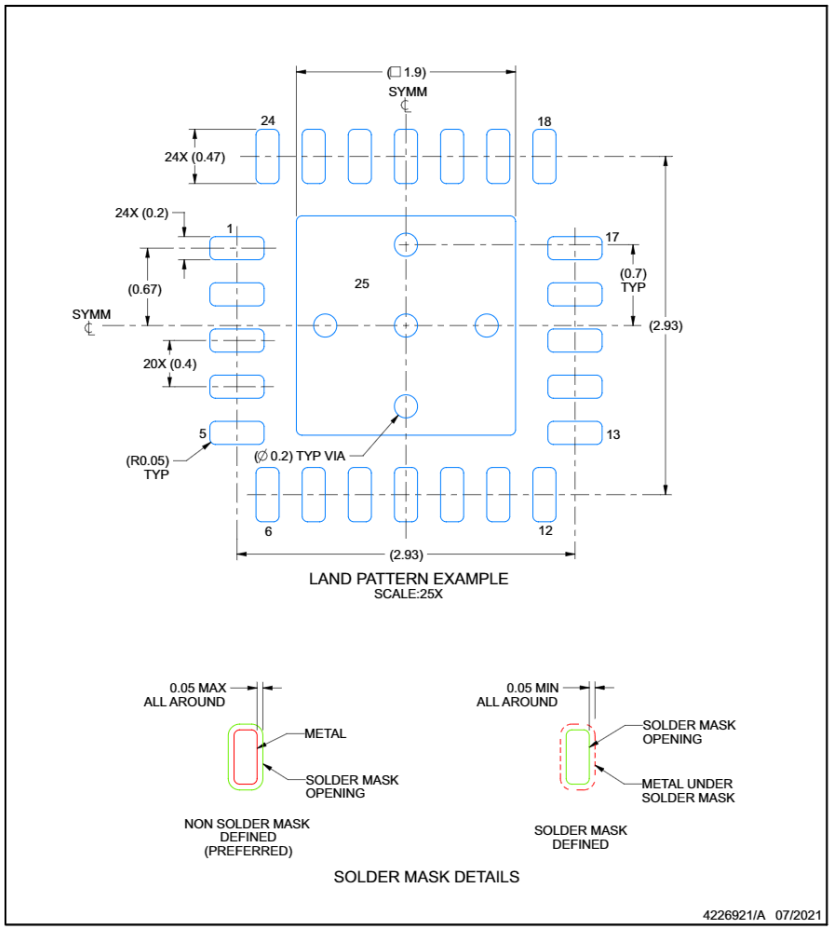
EXAMPLE BOARD LAYOUT

RRW0024A — **WQFN - 0.8 mm max height**

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

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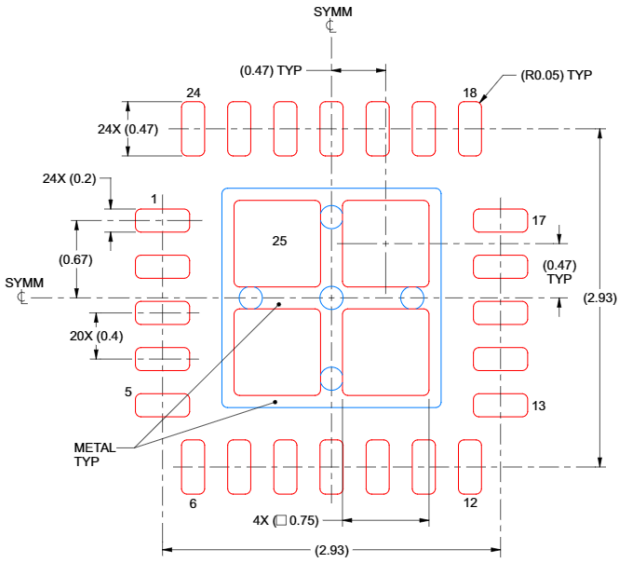
ADVANCE INFORMATION

ADVANCE INFORMATION

EXAMPLE STENCIL DESIGN

RRW0024A — **WQFN - 0.8 mm max height**

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL

EXPOSED PAD 21:
78% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:25X

4226921/A 07/2021

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

TEXAS INSTRUMENTS
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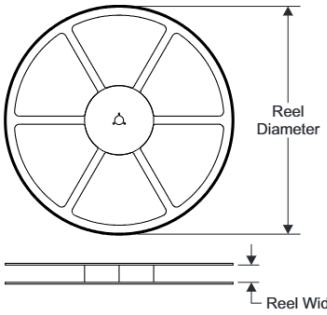
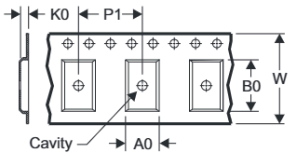
13.1 Tape and Reel Information

REEL DIMENSIONS

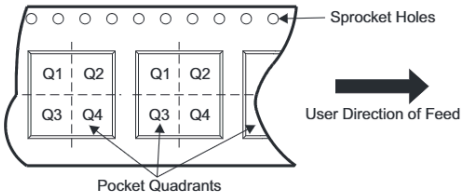


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

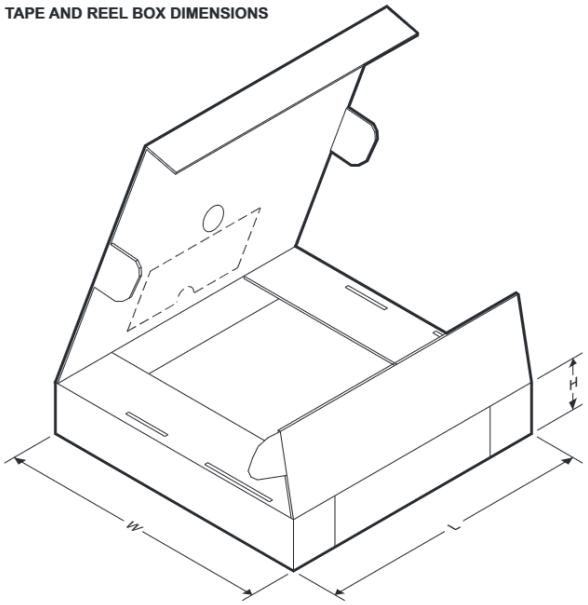
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
PDRV8311PRRWR	WQFN-24	RRW	24	5000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
PDRV8311HRRWR	WQFN-24	RRW	24	5000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

ADVANCE INFORMATION

TAPE AND REEL BOX DIMENSIONS



Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
PDRV8311PRRWR	WQFN-24	RRW	24	5000	367.0	367.0	35.0
PDRV8311HRRWR	WQFN-24	RRW	24	5000	367.0	367.0	35.0

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
DRV8311HRRWR	PREVIEW	WQFN	RRW	24	5000	TBD	Call TI	Call TI	-40 to 125		
DRV8311PRRWR	PREVIEW	WQFN	RRW	24	5000	TBD	Call TI	Call TI	-40 to 125		
PDRV8311HRRWR	ACTIVE	WQFN	RRW	24	5000	TBD	Call TI	Call TI	-40 to 125		Samples
PDRV8311PRRWR	ACTIVE	WQFN	RRW	24	5000	TBD	Call TI	Call TI	-40 to 125		Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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